

# TEST REPORT

of

FCC Part 15 Subpart C §15.247

FCC ID: A3LXE513C24

Equipment Under Test : SAMSUNG NOTEBOOK  
Model Name : XE513C24  
Applicant : Samsung Electronics Co., Ltd.  
Manufacturer : Samsung Electronics Co., Ltd.  
Date of Receipt : 2016.09.05  
Date of Test(s) : 2016.09.08 ~ 2016.09.21  
Date of Issue : 2016.09.22

In the configuration tested, the EUT complied with the standards specified above.

Tested By:



Youngmin Park

Date:

2016.09.22

Technical  
Manager:



Alvin Kim

Date:

2016.09.22

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

---

# INDEX

<u>Table of Contents</u>	Page
1. General Information -----	3
2. Transmitter Radiated Spurious Emissions and Conducted Spurious Emission -----	7
3. 20 dB Bandwidth -----	37
4. Maximum Peak Conducted Output power -----	43
5. Carrier Frequency Separation -----	45
6. Number of Hopping Frequencies -----	48
7. Time of Occupancy(Dwell Time) -----	52
8. AC Power Line Conducted Emission -----	65
9. Antenna Requirement -----	69

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## 1. General Information

### 1.1. Testing Laboratory

SGS Korea Co., Ltd. (Gunpo Laboratory)

-Wireless Div. 2FL, 10-2, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807

All SGS services are rendered in accordance with the applicable SGS conditions of service available on request and accessible at <http://www.sgs.com/en/Terms-and-Conditions.aspx>.

Phone No. : +82 31 688 0901

Fax No. : +82 31 688 0921

### 1.2. Details of Applicant

Applicant : Samsung Electronics Co., Ltd.

Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Korea

Contact Person : Kim, Tae-Hoon

Phone No. : +82 31 277 4488

### 1.3. Description of EUT

<b>Kind of Product</b>	SAMSUNG NOTEBOOK	
<b>Model Name</b>	XE513C24	
<b>Power Supply</b>	DC 7.6 V (AC Adaptor output DC 15 V)	
<b>Frequency Range</b>	2 402 Mhz ~ 2 480 Mhz (Bluetooth, Bluetooth Low Energy), 2 412 Mhz ~ 2 462 Mhz (11b/g/n_HT20), 2 422 Mhz ~ 2 452 Mhz (11n_HT40), 5 745 Mhz ~ 5 825 Mhz (Band 3: 11a/n_HT20, 11ac_VHT20), 5 755 Mhz ~ 5 795 Mhz (Band 3: 11n_HT40, 11ac_VHT40), 5 775 Mhz (Band 3: 11ac_VHT80), 5 180 Mhz ~ 5 240 Mhz (Band 1: 11a/n_HT20, 11ac_VHT20), 5 190 Mhz ~ 5 230 Mhz (Band 1: 11n_HT40, 11ac_VHT40), 5 210 Mhz (Band 1: 11ac_VHT80), 5 260 Mhz ~ 5 320 Mhz (Band 2A: 11a/n_HT20, 11ac_VHT20), 5 270 Mhz ~ 5 310 Mhz (Band 2A: 11n_HT40, 11ac_VHT40), 5 290 Mhz (Band 2A: 11ac_VHT80), 5 500 Mhz ~ 5 720 Mhz (Band 2C: 11a/n_HT20, 11ac_VHT20), 5 510 Mhz ~ 5 710 Mhz (Band 2C: 11n_HT40, 11ac_VHT40), 5 530 Mhz ~ 5 690 Mhz (Band 2C: 11ac_VHT80)	
<b>Modulation Technique</b>	DSSS, OFDM, GFSK, $\pi/4$ DQPSK, 8DPSK	
<b>Number of Channels</b>	79 channels (Bluetooth), 40 channels (Bluetooth Low Energy), 11 channels (11b/g/n_HT20), 7 channels (11n_HT40), 5 channels (Band 3: 11a/n_HT20, 11ac_VHT20), 2 channels (Band 3: 11n_HT40, 11ac_VHT40), 1 channel (Band 3: 11ac_VHT80), 4 channels (Band 1: 11a/n_HT20, 11ac_VHT20), 2 channels (Band 1: 11n_HT40, 11ac_VHT40), 1 channel (Band 1: 11ac_VHT80), 4 channels (Band 2A: 11a/n_HT20, 11ac_VHT20), 2 channels (Band 2A: 11n_HT40, 11ac_VHT40), 1 channel (Band 2A: 11ac_VHT80), 9 channels (Band 2C: 11a/n_HT20, 11ac_VHT20), 4 channels (Band 2C: 11n_HT40, 11ac_VHT40), 2 channels (Band 2C: 11ac_VHT80)	
<b>Antenna Type</b>	Planer inverted F Antenna	
<b>Antenna Gain</b>	<b>Port#1</b>	2 402 Mhz ~ 2 483.5 Mhz: 1.20 dB i, 5 150 Mhz ~ 5 350 Mhz: 1.88 dB i, 5 470 Mhz ~ 5 725 Mhz: 1.70 dB i, 5 725 Mhz ~ 5 850 Mhz: 0.06 dB i
	<b>Port#2</b>	2 402 Mhz ~ 2 483.5 Mhz: 1.94 dB i, 5 150 Mhz ~ 5 350 Mhz: 3.19 dB i, 5 470 Mhz ~ 5 725 Mhz: 0.66 dB i, 5 725 Mhz ~ 5 850 Mhz: 0.51 dB i

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## 1.4. Declaration by the manufacturer

- Adaptive Frequency Hopping is supported and use at least 20 channels.

## 1.5. Information about the FHSS characteristics:

### 1.5.1. Pseudorandom Frequency Hopping Sequence

The channel is represented by a pseudo-random hopping sequence hopping through the 79 RF channels. The hopping sequence is unique for the piconet and is determined by the Bluetooth device address of the master; the phase in the hopping sequence is determined by the Bluetooth clock of the master. The channel is divided into time slots where each slot corresponds to an RF hop frequency. Consecutive hops correspond to different RF hop frequencies. The nominal hop rate is 1 600 hops/s.

### 1.5.2. Equal Hopping Frequency Use

The channels of this system will be used equally over the long-term distribution of the hopsets.

### 1.5.3. Example of a 79 hopping sequence in data mode:

02, 05, 31, 24, 20, 10, 43, 36, 30, 23, 40, 06, 21, 50, 44, 09, 71, 78, 01, 13, 73, 07, 70, 72, 35, 62, 42, 11, 41, 08, 16, 29, 60, 15, 34, 61, 58, 04, 67, 12, 22, 53, 57, 18, 27, 76, 39, 32, 17, 77, 52, 33, 56, 46, 37, 47, 64, 49, 45, 38, 69, 14, 51, 26, 79, 19, 28, 65, 75, 54, 48, 03, 25, 66, 05, 16, 68, 74, 59, 63, 55

### 1.5.4. System Receiver Input Bandwidth

Each channel bandwidth is 1 MHz.

The system receivers have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shift frequencies in synchronization with the transmitted signals.

### 1.5.5. Equipment Description

15.247(a)(1) that the rx input bandwidths shift frequencies in synchronization with the transmitted signals.

15.247(g): In accordance with the Bluetooth Industry Standard, the system is designed to comply with all of the regulations in Section 15.247 when the transmitter is presented with a continuous data (or information) system.

15.247(h): In accordance with the Bluetooth Industry Standard, the system does not coordinate its channels selection/ hopping sequence with other frequency hopping systems for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters.

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsaroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)

## 1.6. Test Equipment List

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Interval	Cal. Due
Signal Generator	Agilent	E8257D	MY51501169	Jul. 07, 2016	Annual	Jul. 07, 2017
Signal Generator	R&S	SMBV100A	255834	Jun. 20, 2016	Annual	Jun. 20, 2017
Spectrum Analyzer	R&S	FSV30	103453	Dec. 04, 2015	Annual	Dec. 04, 2016
Spectrum Analyzer	Agilent	N9030A	MY53120526	Jun. 24, 2016	Annual	Jun. 24, 2017
Bluetooth Tester	TESCOM	TC-3000C	3000C000296	Jun. 20, 2016	Annual	Jun. 20, 2017
Directional Coupler	KRYTAR	152613	140972	Jun. 07, 2016	Annual	Jun. 07, 2017
High Pass Filter	Wainwright Instrument GmbH	WHK3.0/18G-6SS	4	Jun. 18, 2016	Annual	Jun. 18, 2017
High Pass Filter	Wainwright Instrument GmbH	WHNX7.5/26.5G-6SS	11	Jun. 03, 2016	Annual	Jun. 03, 2017
Low Pass Filter	Mini-Circuits	NLP-1200+	V 8979400903-2	Feb. 29, 2016	Annual	Feb. 28, 2017
Power Sensor	R&S	NRP-Z81	100253	Mar. 22, 2016	Annual	Mar. 22, 2017
DC Power Supply	Agilent	U8002A	MY53150029	Jun. 20, 2016	Annual	Jun. 20, 2017
Preamplifier	H.P.	8447F	2944A03909	Aug. 11, 2016	Annual	Aug. 11, 2017
Preamplifier	R&S	SCU-18	10117	Apr. 07, 2016	Annual	Apr. 07, 2017
Preamplifier	MITEQ Inc.	JS44-18004000-35-8P	1546891	May 12, 2016	Annual	May 12, 2017
Loop Antenna	Schwarzbeck Mess-Elektronik	FMZB 1519	1519-039	Aug. 19, 2015	Biennial	Aug. 19, 2017
Bilog Antenna	Schwarzbeck Mess-Elektronik	VULB9163	396	Jun. 18, 2015	Biennial	Jun. 18, 2017
Horn Antenna	R&S	HF906	100326	Feb. 01, 2016	Biennial	Feb. 01, 2018
Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA 9170	BBHA9170431	Aug. 25, 2016	Biennial	Aug. 25, 2018
Antenna Master	INNCO systems	MA4640-XP-ET	N/A	N.C.R.	N/A	N.C.R.
Turn Table	INNCO systems	CONTROLLER CO3000	N/A	N.C.R.	N/A	N.C.R.
Test Receiver	R&S	ESU26	100109	Mar. 07, 2016	Annual	Mar. 07, 2017
Anechoic Chamber	SY Corporation	L x W x H (9.6 m x 6.4 m x 6.6 m)	N/A	N.C.R.	N/A	N.C.R.
Test Receiver	R&S	ESCI 7	100911	Dec. 22, 2015	Annual	Dec. 22, 2016
Two-Line V-Network	R&S	ENV216	100190	Dec. 21, 2015	Annual	Dec. 21, 2016
Shield Room	SY Corporation	L x W x H (6.5 m x 3.5 m x 3.5 m)	N/A	N.C.R.	N/A	N.C.R.

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## 1.7. Summary of Test Results

The EUT has been tested according to the following specifications:

APPLIED STANDARD:FCC Part15 subpart C		
Standard Section	Test Item	Result
15.205(a) 15.209 15.247(d)	Transmitter Radiated Spurious Emissions Conducted Spurious Emission	Complied
15.247(a)(1)	20 dB Bandwidth	Complied
15.247(b)(1)	Maximum Peak Conducted Output Power	Complied
15.247(a)(1)	Carrier Frequency Separation	Complied
15.247(a)(1)(iii)	Number of Hopping Frequency	Complied
15.247(a)(1)(iii)	Time of Occupancy (Dwell Time)	Complied
15.207	AC Power Line Conducted Emission	Complied

## 1.8. Test Procedure(s)

The measurement procedures described in the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2013) and the guidance provided in DA 00-705 were used in the measurement of the DUT.

## 1.9. Sample calculation

Where relevant, the following sample calculation is provided:

### 1.9.1. Conducted test

Offset value (dB) = Directional Coupler (dB) + Cable loss (dB)

### 1.9.2. Radiation test

Field strength level (dB $\mu$ V/m) = Measured level (dB $\mu$ V) + Antenna factor (dB) + Cable loss (dB) - Amplifier gain (dB)

## 1.10. Test report revision

Revision	Report number	Date of Issue	Description
0	F690501/RF-RTL010354	2016.09.22	Initial

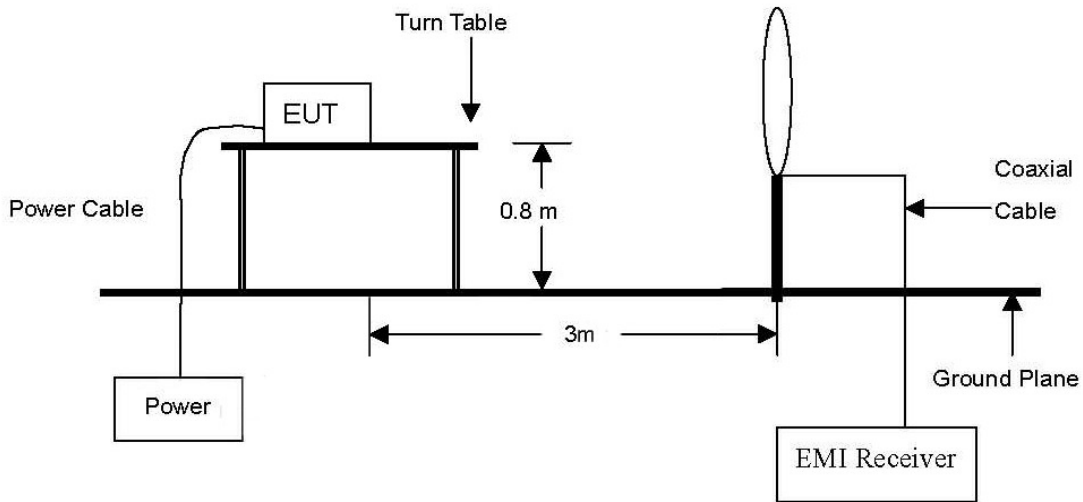
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

## 2. Transmitter Radiated Spurious Emissions and Conducted Spurious Emission

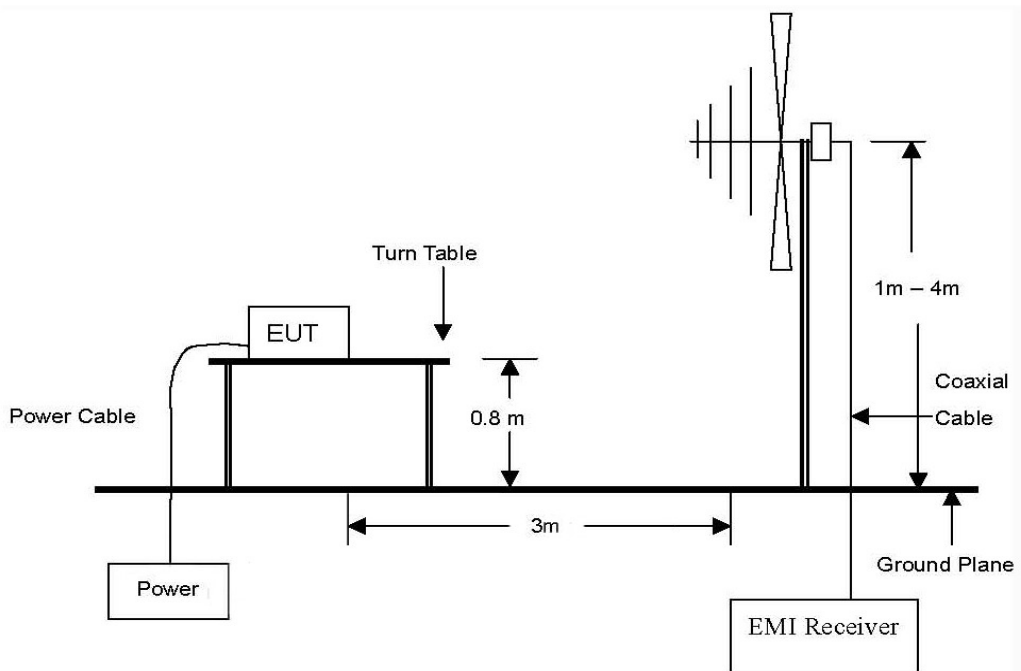
### 2.1. Test Setup

#### 2.1.1. Transmitter Radiated Spurious Emissions

The diagram below shows the test setup that is utilized to make the measurements for emission from 9 kHz to 30 MHz Emissions.

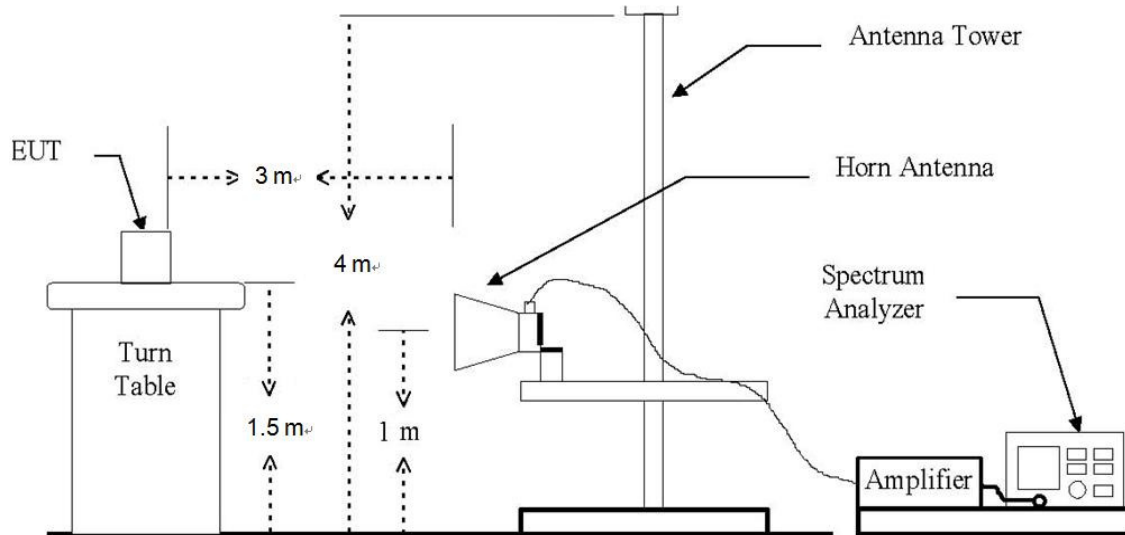


The diagram below shows the test setup that is utilized to make the measurements for emission from 30 MHz to 1 GHz Emissions.



*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

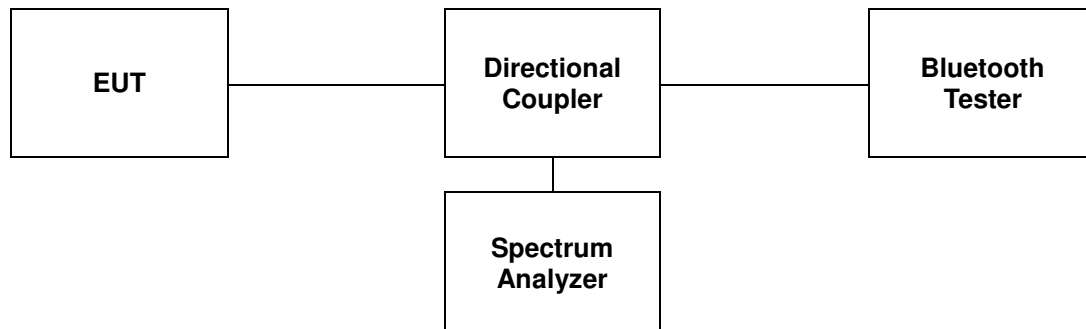
The diagram below shows the test setup that is utilized to make the measurements for emission. The spurious emissions were investigated from 1 GHz to the 10<sup>th</sup> harmonic of the highest fundamental frequency or 40 GHz, whichever is lower.



*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*



### 2.1.2. Conducted Spurious Emissions



### 2.2. Limit

According to §15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph(b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in section §15.209(a) is not required. In addition, radiated emission which in the restricted band, as define in section §15.205(a), must also comply the radiated emission limits specified in section §15.209(a) (see section §15.205(c))

According to §15.209(a), Except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table :

Frequency (MHz)	Distance (Meters)	Field Strength (dB $\mu$ V/m)	Field Strength ( $\mu$ V/m)
0.009 – 0.490	300	20 log (2 400/F(kHz))	2 400/F(kHz)
0.490 – 1.705	30	20 log (24 000/F(kHz))	24 000/F(kHz)
1.705 – 30.0	30	29.54	30
30 – 88	3	40.0	100
88 – 216	3	43.5	150
216 – 960	3	46.0	200
Above 960	3	54.0	500

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

## 2.3. Test Procedures

Radiated emissions from the EUT were measured according to the dictates of ANSI C63.10-2013.

### 2.3.1. Test Procedures for emission below 30 MHz

1. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter anechoic chamber test site. The table was rotated 360 degrees to determine the position of the highest radiation.
2. Then antenna is a loop antenna is fixed at one meter above the ground to determine the maximum value of the field strength. Both parallel and perpendicular of the antenna are set to make the measurement.
3. For each suspected emission, the EUT was arranged to its worst case and then the table was turned from 0 degrees to 360 degrees to find the maximum reading.
4. The test-receiver system was set to average or quasi peak detect function and Specified Bandwidth with Maximum Hold Mode.

#### Note;

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 meter open field test site.

Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 937606.

### 2.3.2. Test Procedures for emission from above 30 MHz

1. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter anechoic chamber test site below 1 GHz and 1.5 meter above the ground at a 3 meter anechoic chamber test site above 1 GHz. The table was rotated 360 degrees to determine the position of the highest radiation.
2. During performing radiated emission below 1 GHz, the EUT was set 3 meters away from the interference receiving antenna, which was mounted on the top of a variable-height antenna tower. During performing radiated emission above 1 GHz, the EUT was set 3 meter away from the interference-receiving antenna.
3. The antenna is a bi-log antenna, a horn antenna and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
4. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the table was turned from 0 degrees to 360 degrees to find the maximum reading.
5. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
6. If the emission level of the EUT in peak mode was 10 dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10 dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**NOTE;**

All data rates and modes were investigated for radiated spurious emissions. Only the radiated emissions of the configuration that produced the worst case emissions are reported in this section.

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for Peak detection (PK) and Quasi-peak detection (QP) at frequency below 1 GHz.
2. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 1 MHz for Peak detection and frequency above 1 GHz.
3. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is  $1/T_{on}$  Hz ( $T_{on}$  = On-time of the Pulsed emission) for Average detection (AV) at frequency above 1 GHz.  
VBW = 360 Hz  $\geq 1/T_{on}$  Hz, pulse width in seconds ( $T_{on}$  = 2.89 ms). Refer to the DH5, 3DH5 of Time of Occupancy (Dwell Time) test item.
4. When Average result is different from peak result over 20 dB (over-averaging), according to §15.35 (c), as a "duty cycle correction factor", pulse averaging with  $20 \log(\text{duty cycle})$  has to be used.
5. To get a maximum emission level from the EUT, the EUT is manipulated through three orthogonal planes(X, Y, Z). Worst orthogonal plan of EUT is **Z – axis** during radiation test.

**2.3.3. Test Procedures for Conducted Spurious Emissions****2.3.3.1. Band-edge Compliance of RF Conducted Emissions**

The transmitter output was connected to the spectrum analyzer.

Span = wide enough to capture the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation.

RBW  $\geq$  100 kHz

VBW  $\geq$  RBW

Sweep = auto

Detector function = peak

Trace = max hold

**2.3.3.2. Spurious RF Conducted Emissions**

The transmitter output was connected to the spectrum analyzer.

RBW = 100 kHz

VBW  $\geq$  RBW

Sweep = auto

Detector function = peak

Trace = max hold

**2.3.3.3. Correction function**

- For plots showing conducted spurious emissions from 9 kHz to 25 GHz, all path loss of wide frequency range was investigated and compensated to spectrum analyzer as Correction function.  
So, the reading values shown in plots were final result.

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsaroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)

## 2.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

### 2.4.1. Radiated Spurious Emission below 1 000 MHz

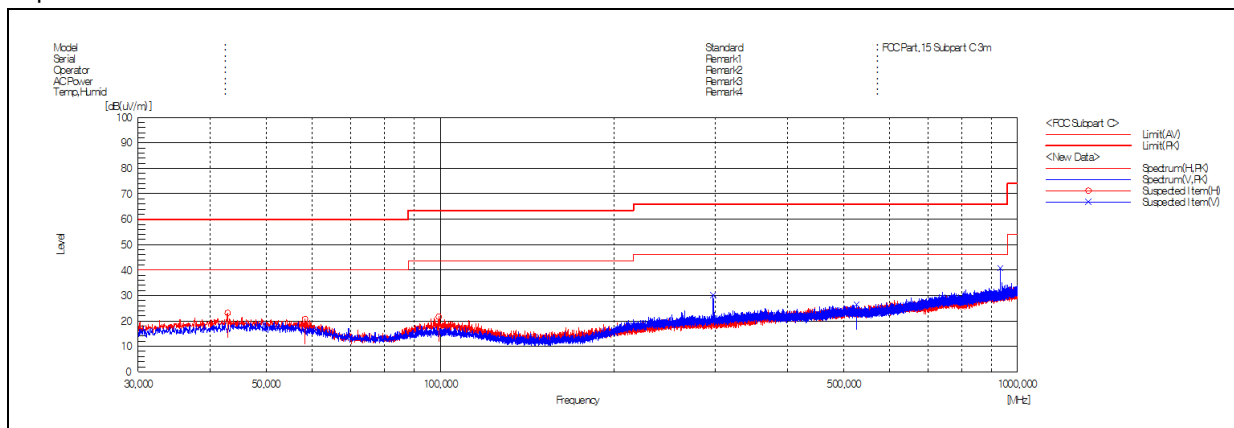
The frequency spectrum from 9 kHz to 1 000 MHz was investigated. All reading values are peak values.

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dBμV)	Detect Mode	Pol.	AF (dB/m)	AMP + CL (dB)	Actual (dBμV/m)	Limit (dBμV/m)	Margin (dB)
42.85	34.10	Peak	H	16.04	-27.14	23.00	40.00	17.00
58.33	32.60	Peak	H	14.79	-26.99	20.40	40.00	19.60
296.99	40.10	Peak	V	15.11	-25.16	30.05	46.00	15.95
525.99	33.70	Peak	V	18.63	-25.86	26.47	46.00	19.53
933.35	41.40	Peak	V	23.71	-24.29	40.82	46.00	5.18

Remark:

- Spurious emissions for all channels and modes were investigated and almost the same below 1 GHz.
- Reported spurious emissions are in **EDR / 3DH5 / Low channel** as worst case among other modes.
- Radiated spurious emission measurement as below.  
(Actual = Reading + AF + AMP + CL)
- According to §15.31(o), emission levels are not report much lower than the limits by over 20 dB.

Test plot



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

### 2.4.2. Radiated Spurious Emission above 1 000 MHz

The frequency spectrum above 1 000 MHz was investigated. All reading values are peak and average values.

#### Operating Mode: GFSK (1 Mbps)

##### A. Low Channel (2 402 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
*2 310.00	25.02	Peak	H	28.07	5.31	58.40	74.00	15.60
*2 310.00	15.70	Average	H	28.07	5.31	49.08	54.00	4.92
*2 389.15	27.43	Peak	H	28.15	5.80	61.38	74.00	12.62
*2 370.48	15.99	Average	H	28.13	5.66	49.78	54.00	4.22
*2 390.00	24.10	Peak	H	28.15	5.80	58.05	74.00	15.95
*2 390.00	15.98	Average	H	28.15	5.80	49.93	54.00	4.07

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## B. Middle Channel (2 441 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

## C. High Channel (2 480 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
*2 483.50	24.55	Peak	H	28.24	5.54	58.33	74.00	15.67
*2 483.50	16.54	Average	H	28.24	5.54	50.32	54.00	3.68
*2 494.07	26.46	Peak	H	28.25	5.51	60.22	74.00	13.78
*2 491.16	16.42	Average	H	28.25	5.52	50.19	54.00	3.81
*2 500.00	23.27	Peak	H	28.26	5.49	57.02	74.00	16.98
*2 500.00	16.43	Average	H	28.26	5.49	50.18	54.00	3.82

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

**Operating Mode: 8DPSK (3 Mbps)**

## A. Low Channel (2 402 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
*2 310.00	24.42	Peak	H	28.07	5.31	57.80	74.00	16.20
*2 310.00	15.76	Average	H	28.07	5.31	49.14	54.00	4.86
*2 358.34	25.68	Peak	H	28.12	5.55	59.35	74.00	14.65
*2 352.84	15.77	Average	H	28.11	5.50	49.38	54.00	4.62
*2 390.00	25.08	Peak	H	28.15	5.80	59.03	74.00	14.97
*2 390.00	15.88	Average	H	28.15	5.80	49.83	54.00	4.17

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

## B. Middle Channel (2 441 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## C. High Channel (2 480 MHz)

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
*2 483.50	24.23	Peak	H	28.24	5.54	58.01	74.00	15.99
*2 483.50	16.58	Average	H	28.24	5.54	50.36	54.00	3.64
*2 493.38	26.69	Peak	H	28.25	5.51	60.45	74.00	13.55
*2 495.72	16.34	Average	H	28.26	5.50	50.10	54.00	3.90
*2 500.00	24.59	Peak	H	28.26	5.49	58.34	74.00	15.66
*2 500.00	16.28	Average	H	28.26	5.49	50.03	54.00	3.97

Radiated Emissions			Ant.	Correction Factors		Total	Limit	
Frequency (MHz)	Reading (dB $\mu$ V)	Detect Mode	Pol.	AF (dB/m)	AMP+CL (dB)	Actual (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)
Above 1 000.00	Not detected	-	-	-	-	-	-	-

## Remarks;

1. "\*" means the restricted band.
2. Measuring frequencies from 1 GHz to the 10<sup>th</sup> harmonic of highest fundamental frequency.
3. Radiated emissions measured in frequency above 1 000 MHz were made with an instrument using peak/average detector mode.
4. Actual = Reading + AF + AMP + CL
5. According to §15.31(o), emission levels are not reported much lower than the limits by over 20 dB.

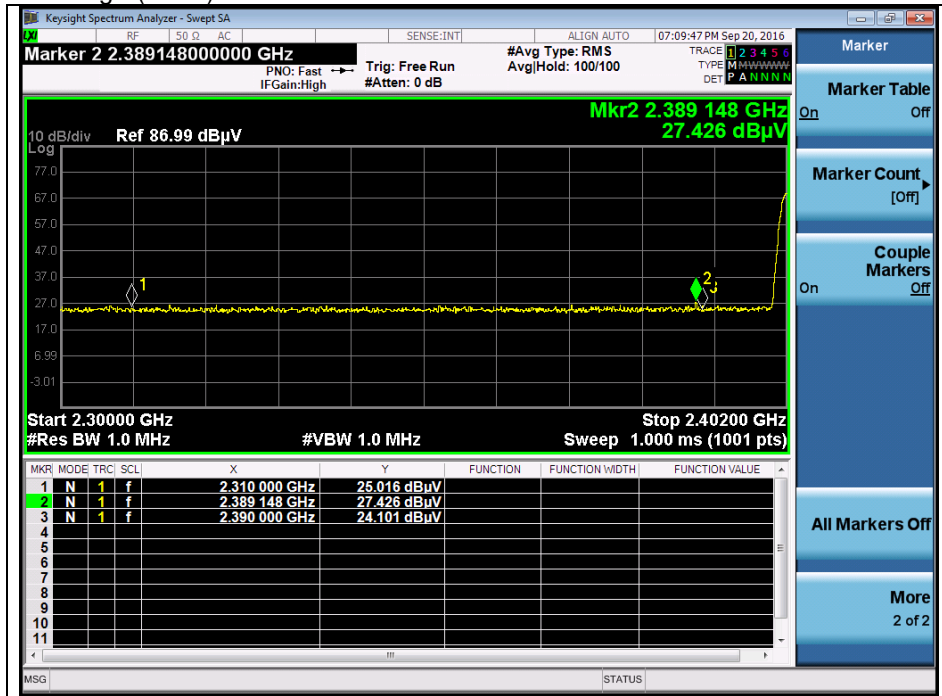
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.



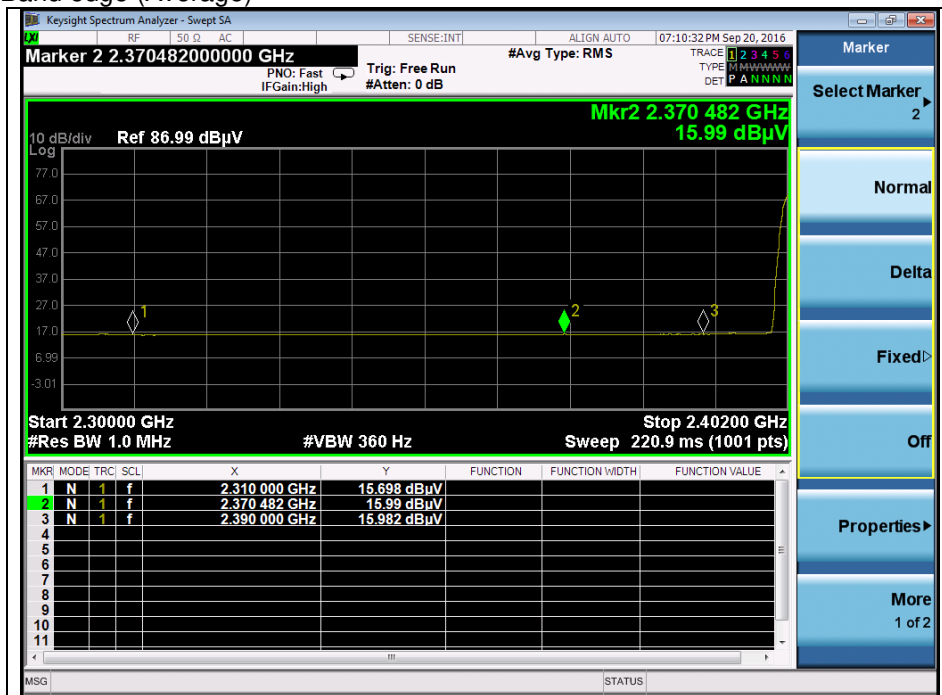
### 2.4.3. Plots of Transmitter Radiated Spurious Emissions

Operating Mode: GFSK (1 Mbps)

Low Channel Band edge (Peak)

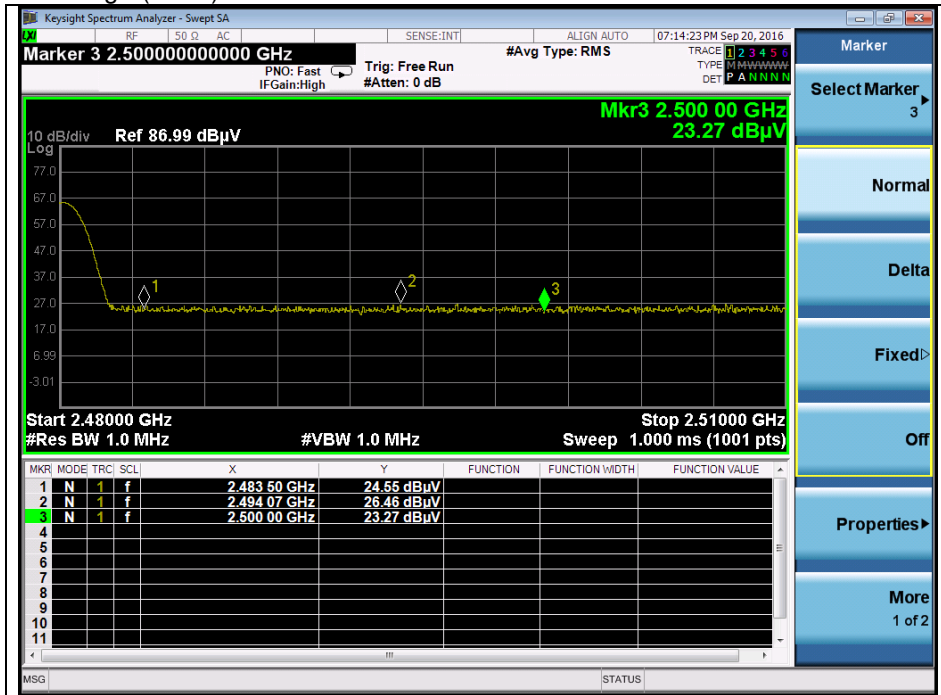


Low Channel Band edge (Average)

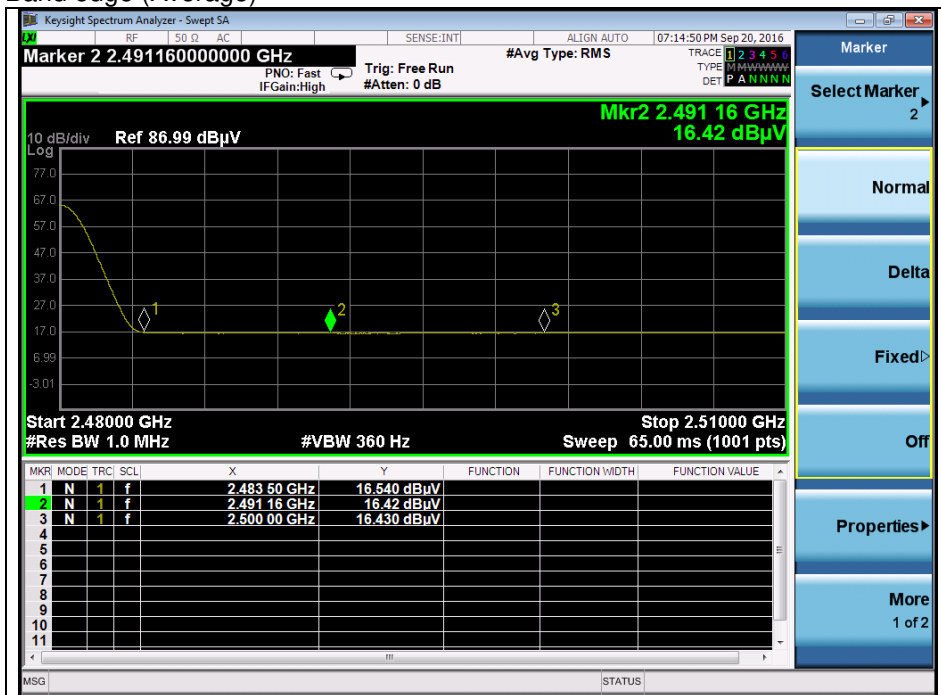


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

### High Channel Band edge (Peak)



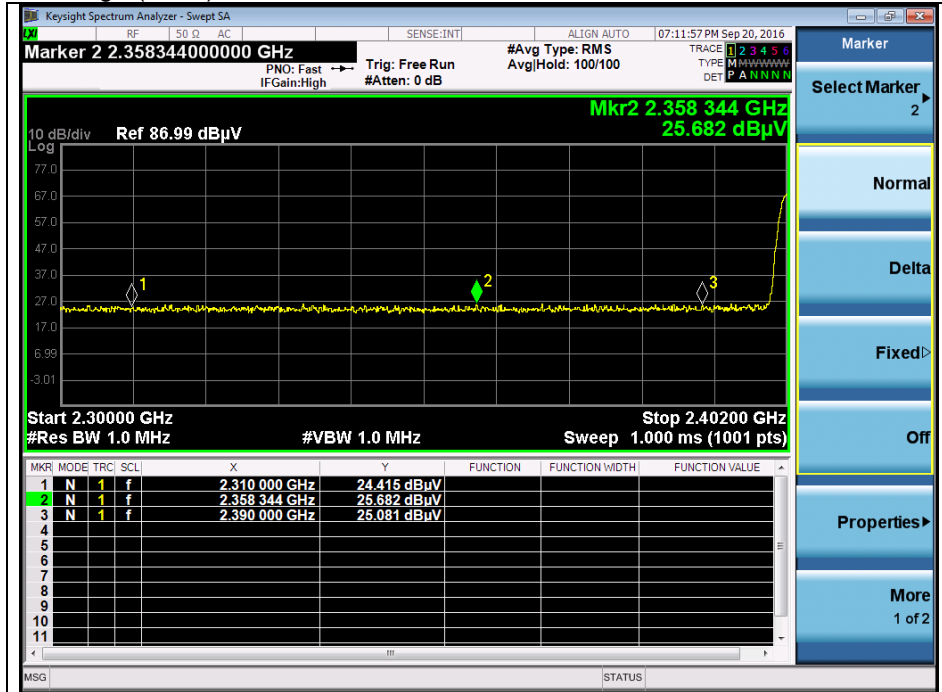
### High Channel Band edge (Average)



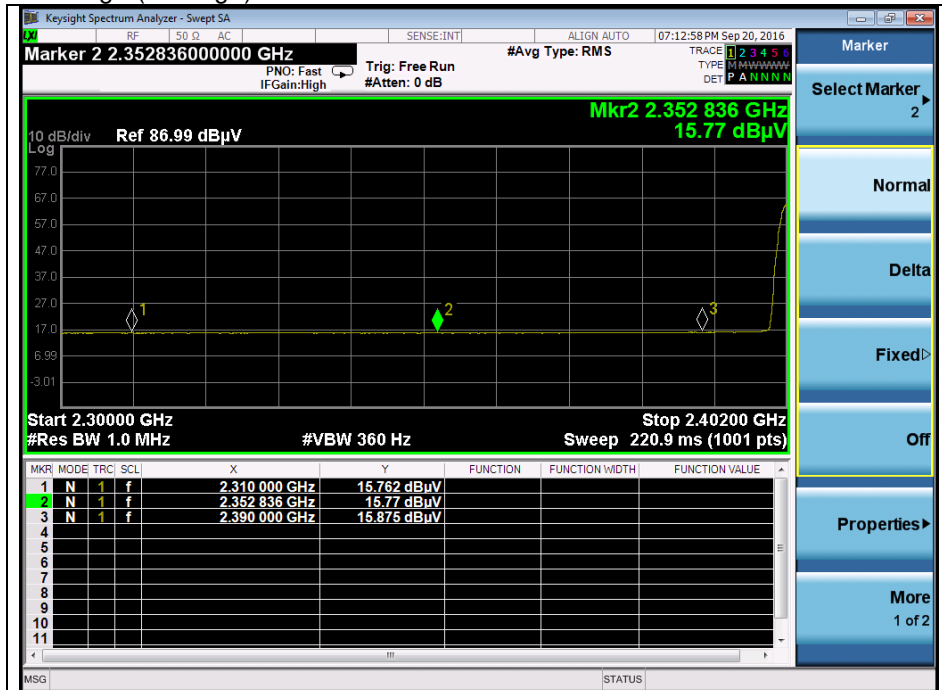
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## Operating Mode: 8DPSK (3 Mbps)

### Low Channel Band edge (Peak)

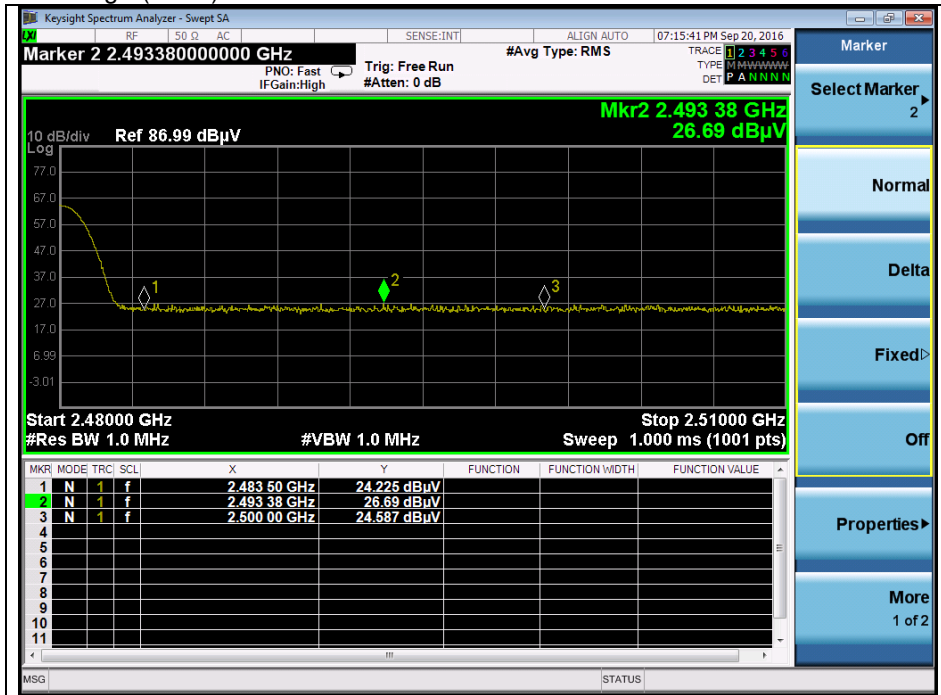


### Low Channel Band edge (Average)

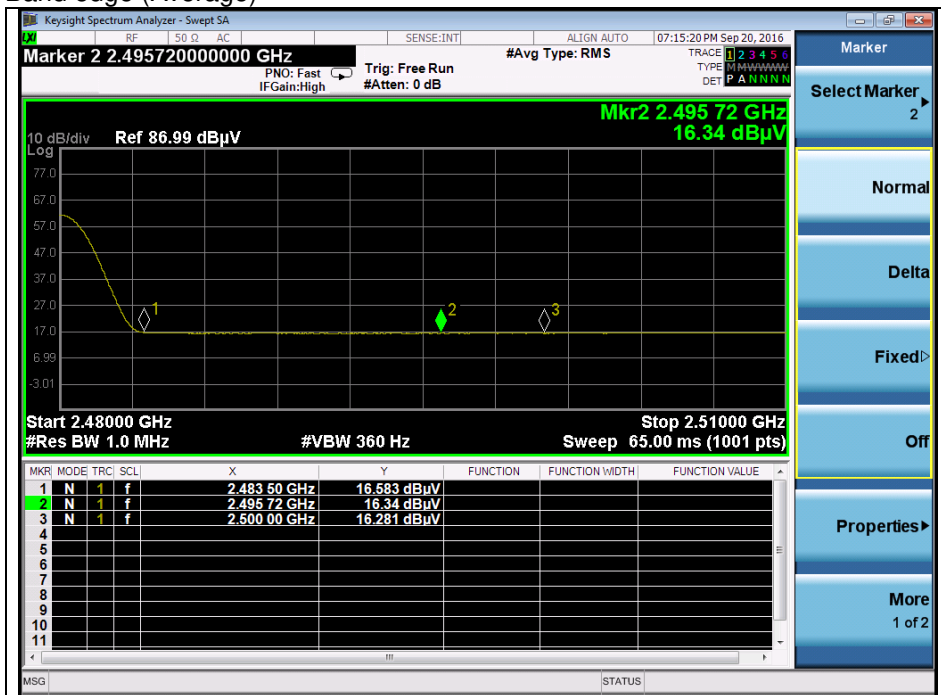


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

### High Channel Band edge (Peak)



### High Channel Band edge (Average)

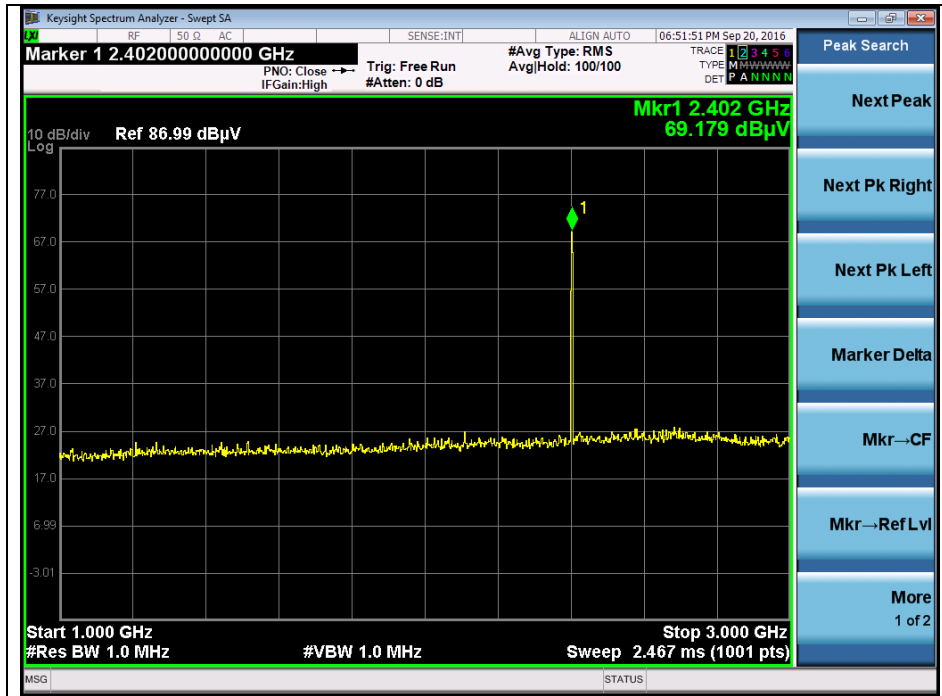


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

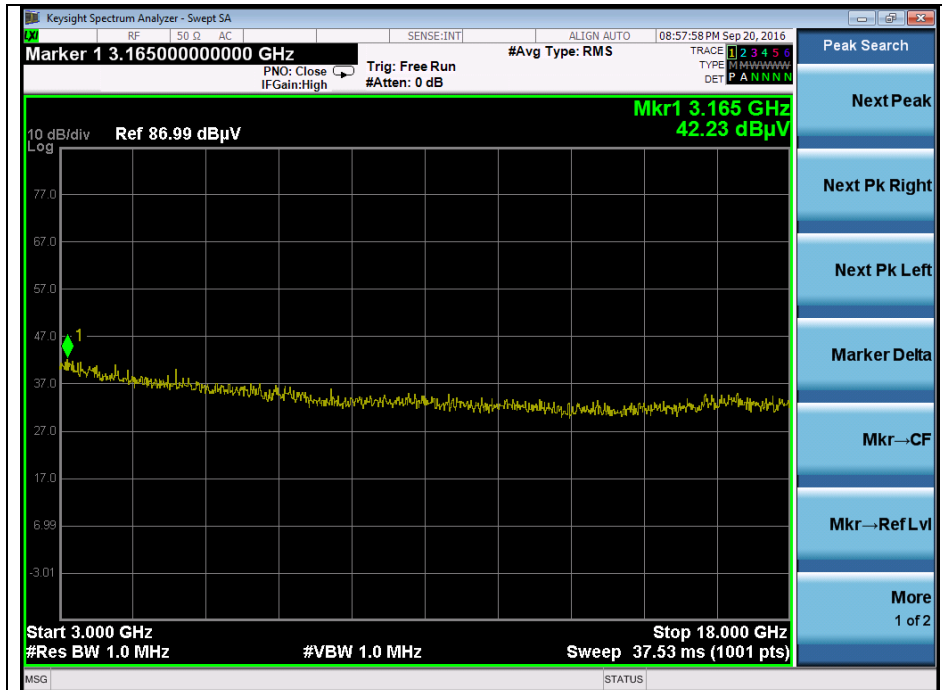
## Pre-scan Test Plots

Operating Mode: GFSK (1 Mbps)

1 GHz ~ 3 GHz



3 GHz ~ 18 GHz

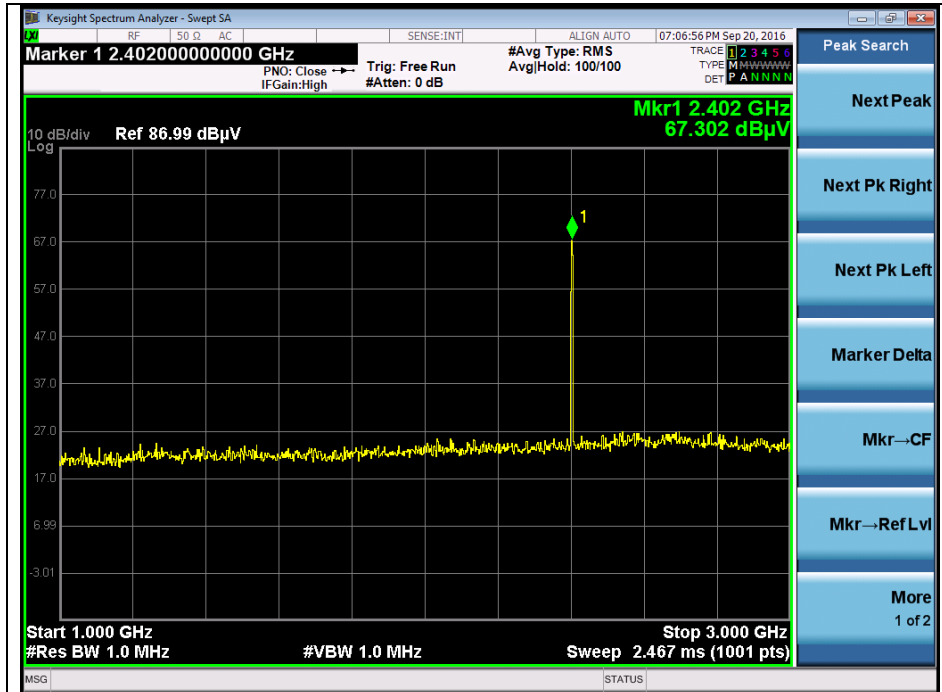


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

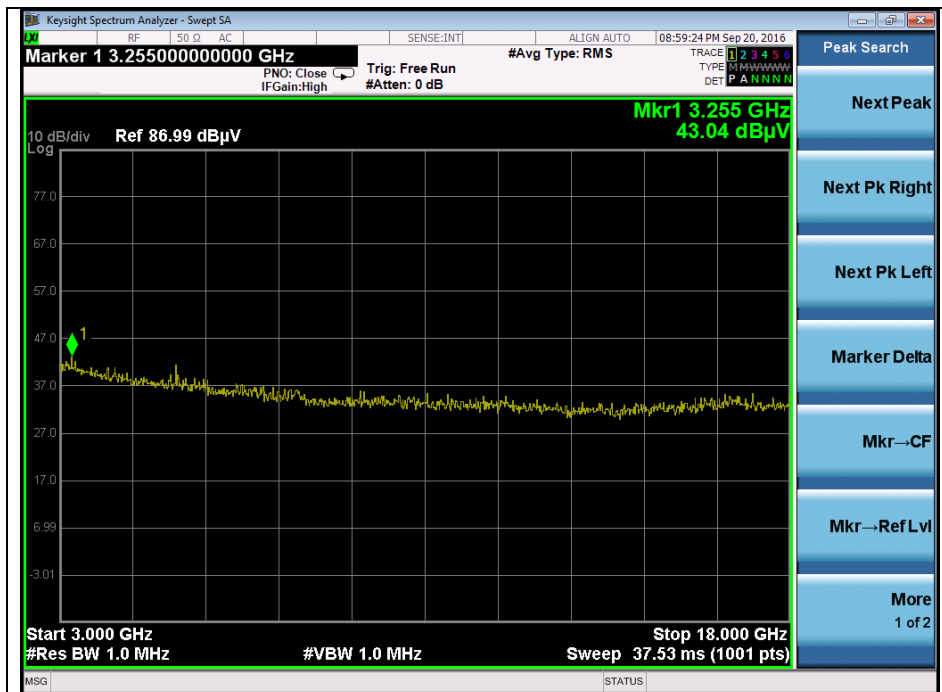
SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsaroup.kr>

**Operating Mode: 8DPSK (3 Mbps)**

1 GHz ~ 3 GHz



3 GHz ~ 18 GHz



**Note:** Emission was scanned up to 25 GHz.

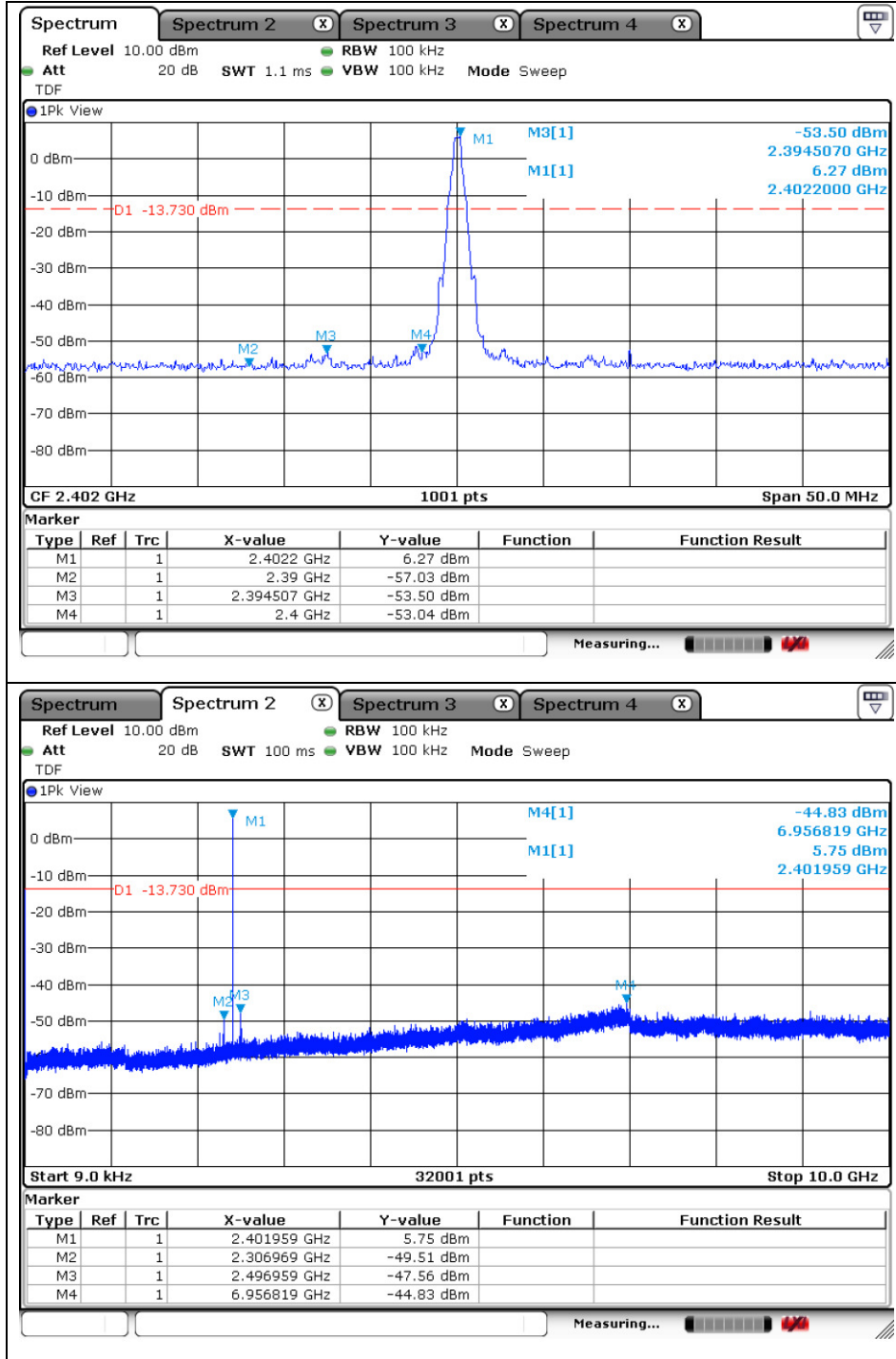
No emissions were detected above the noise floor which was at least 20 dB below the specification limit.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

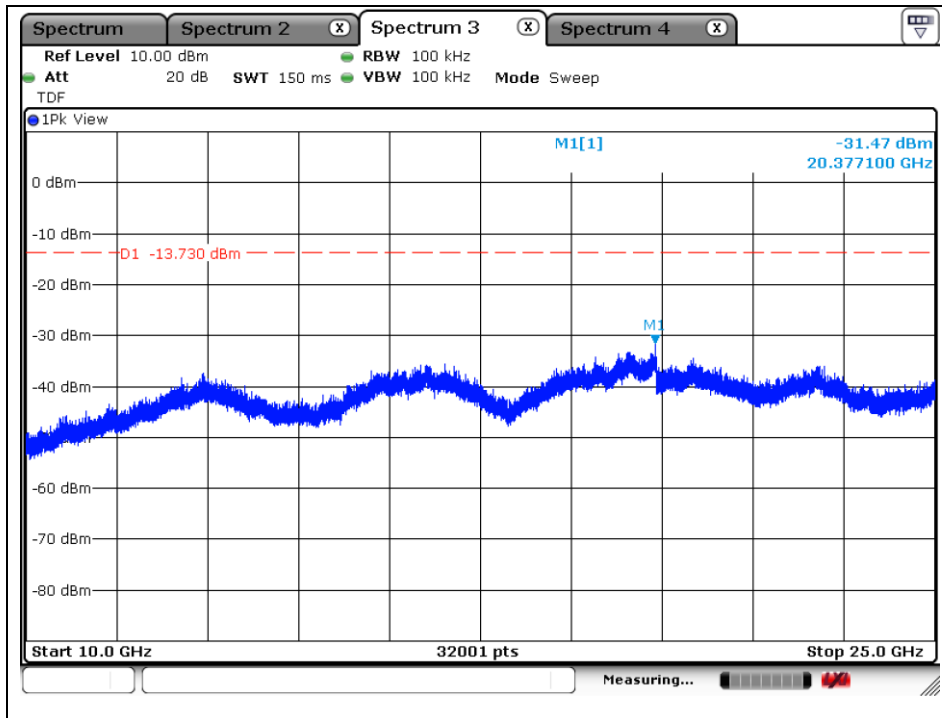
## 2.4.4. Spurious RF Conducted Emissions: Plot of Spurious RF Conducted Emission

Operating Mode: GFSK (1 Mbps)

Low Channel



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

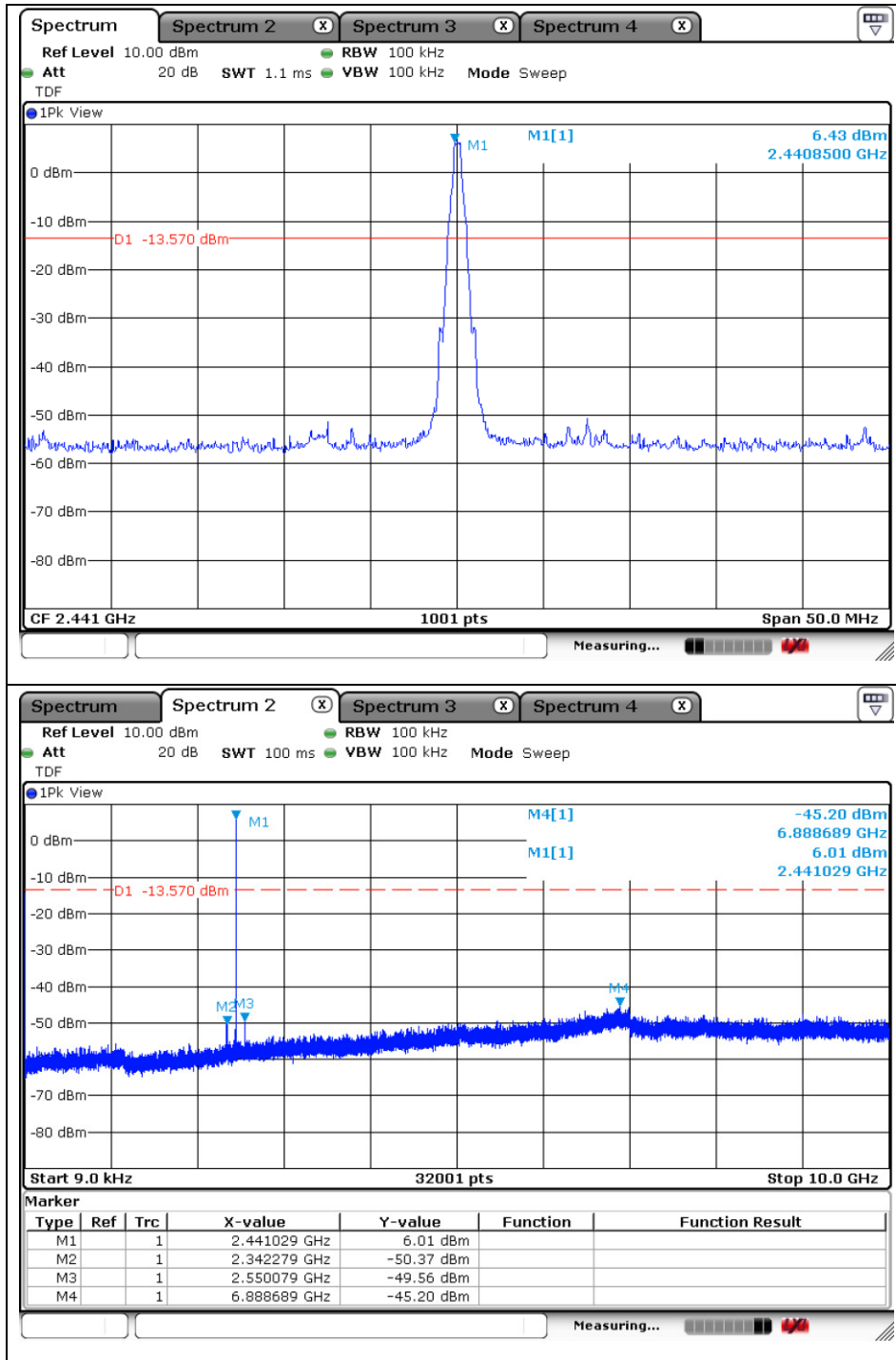


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

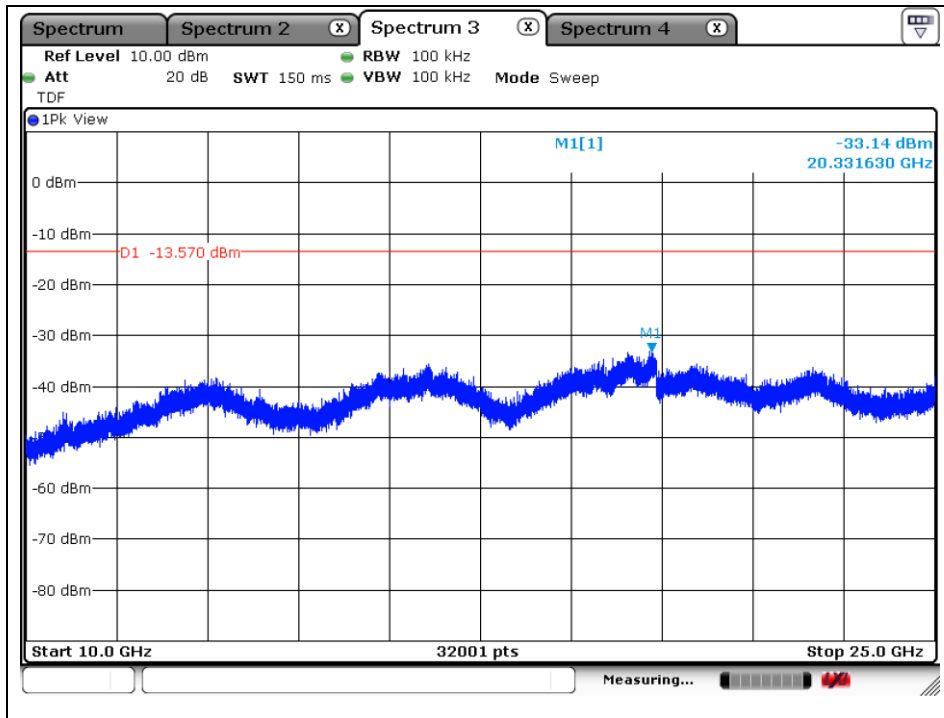
SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>



Middle Channel



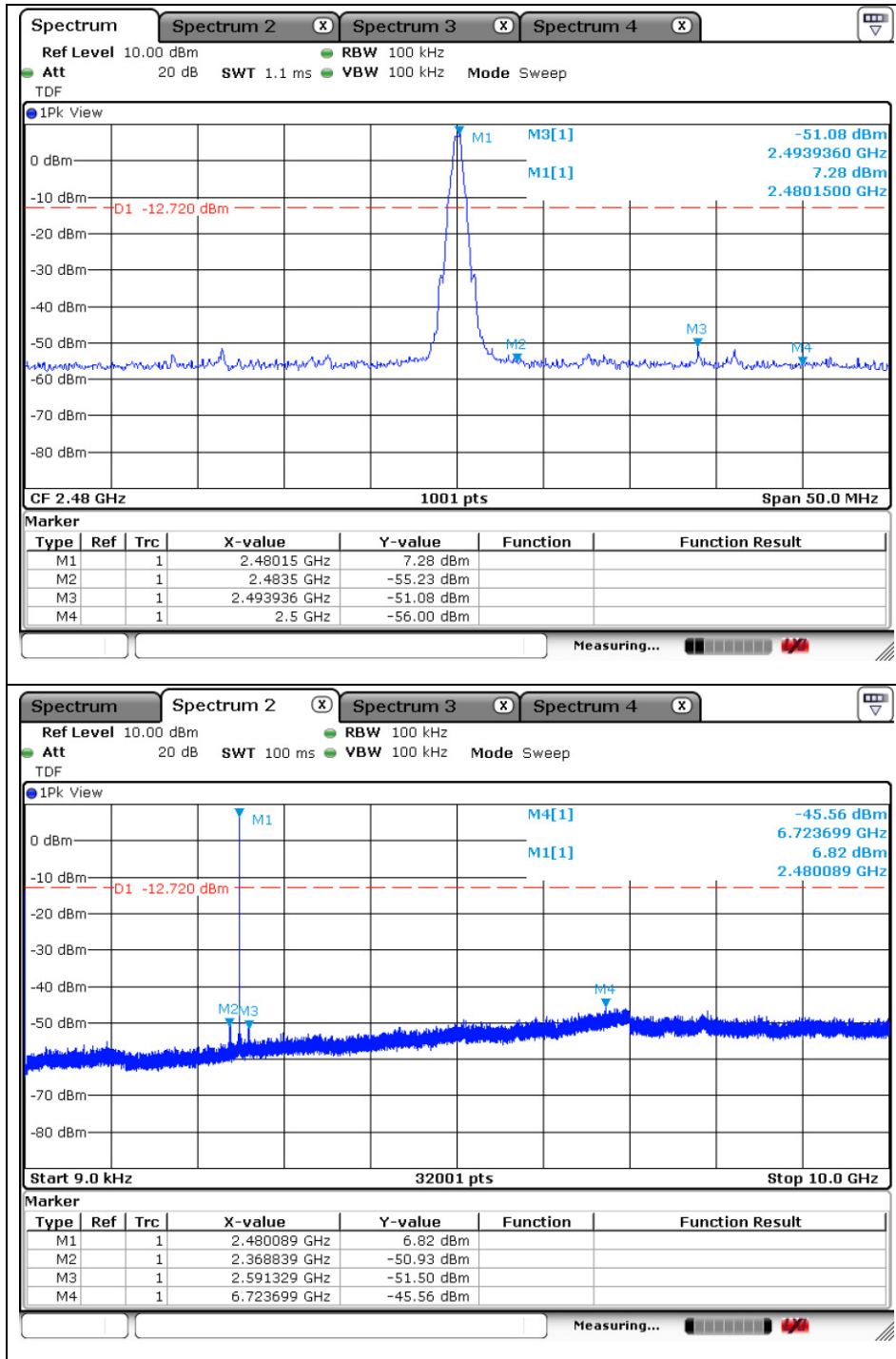
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.



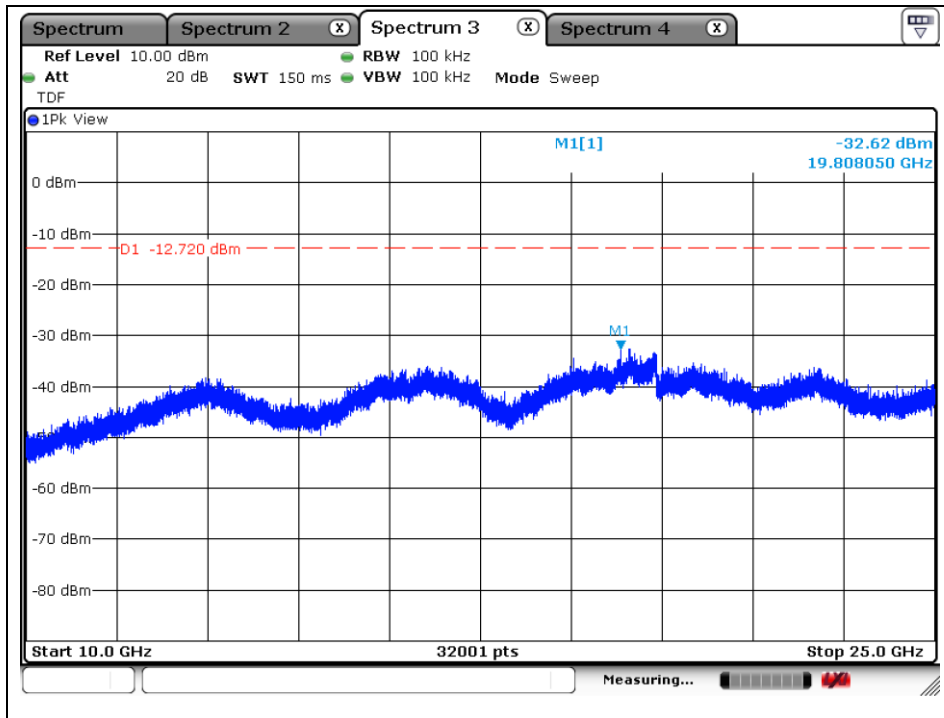
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

High Channel

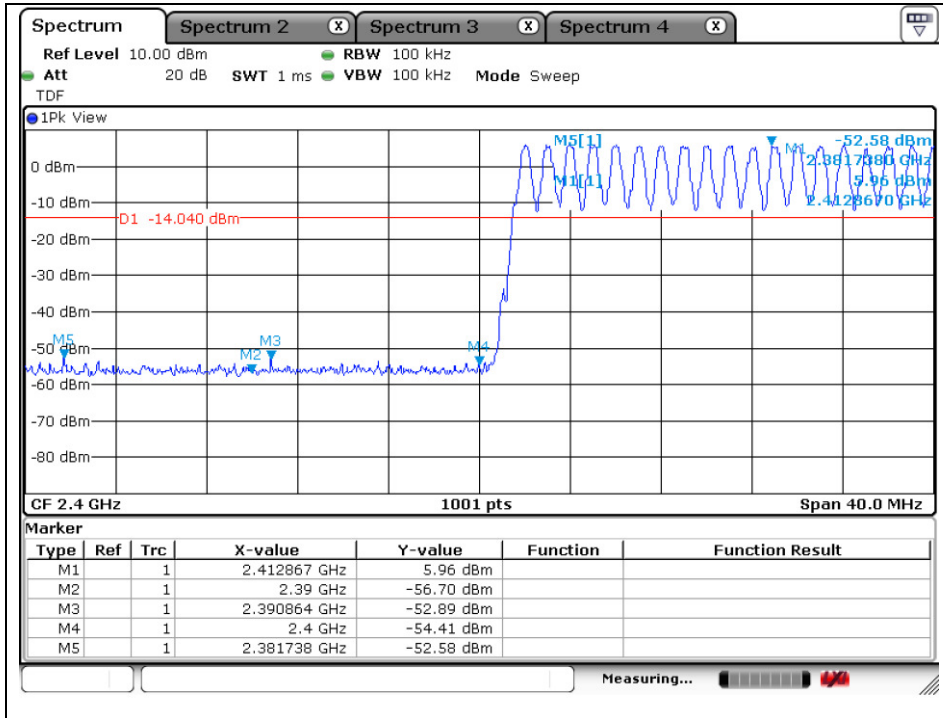


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

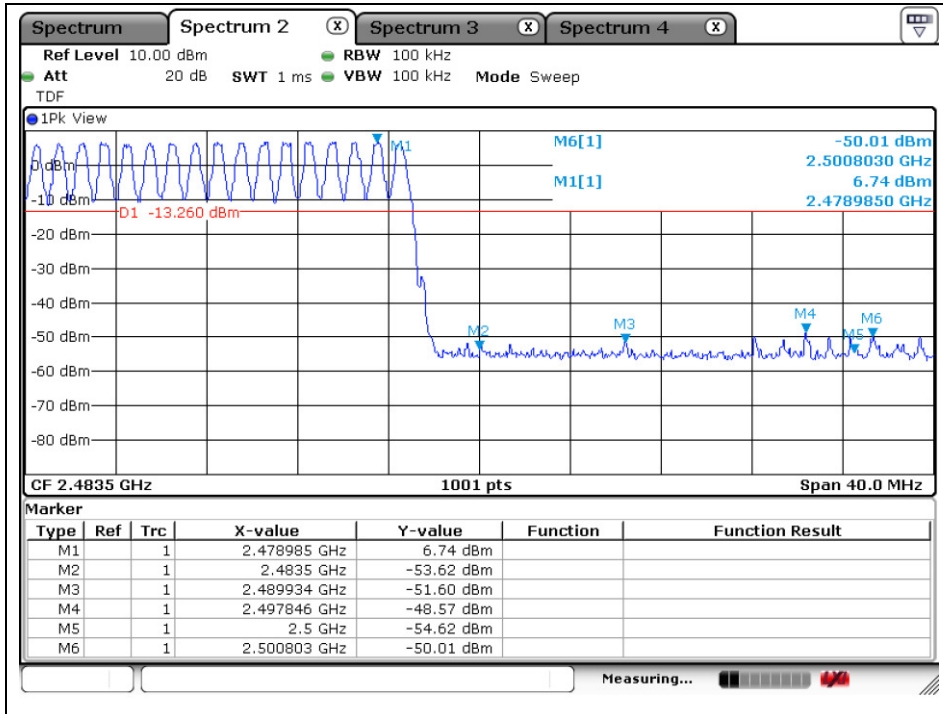


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

Band edge Compliance with Hopping Enabled  
Low channel



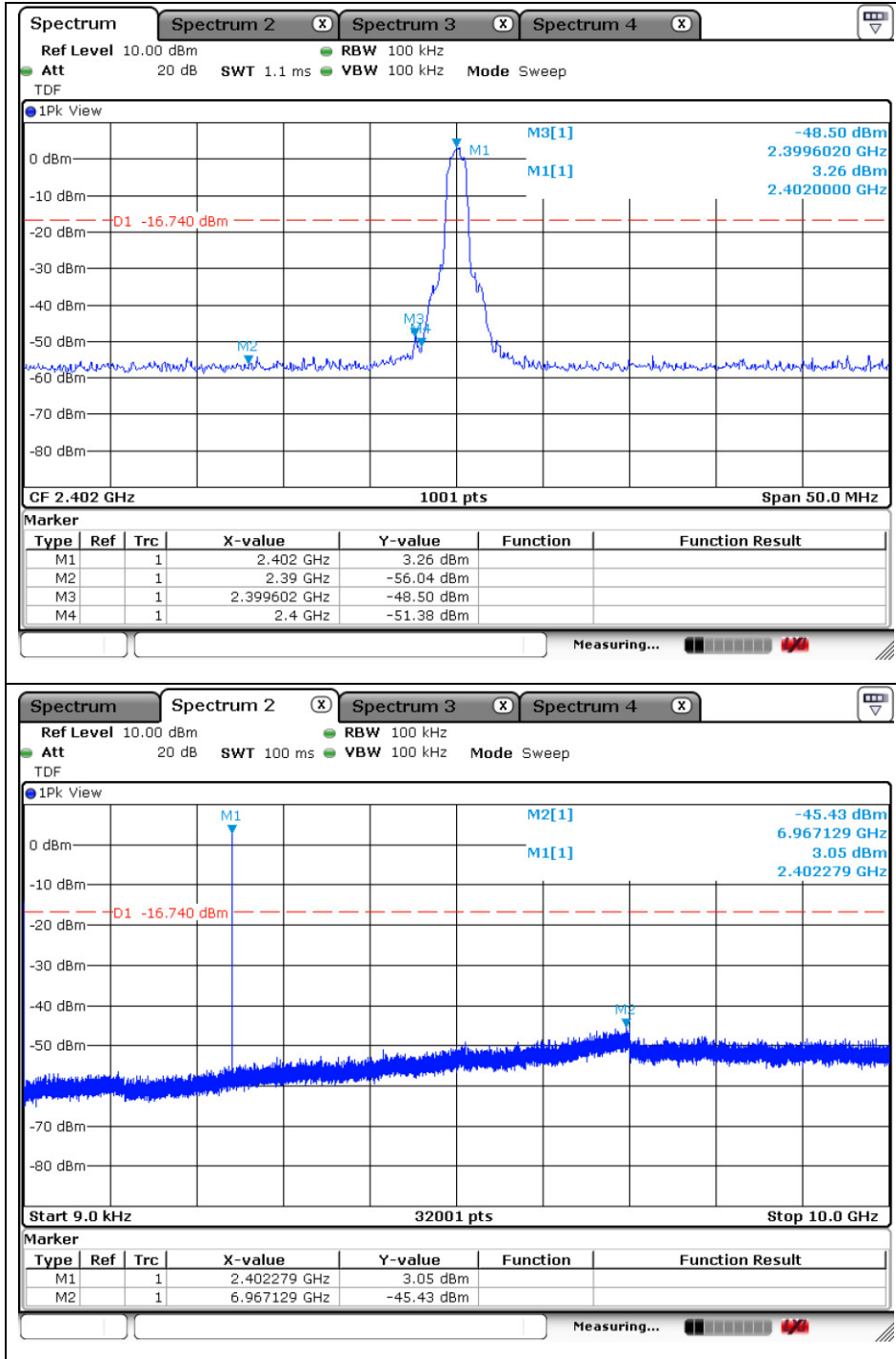
High channel



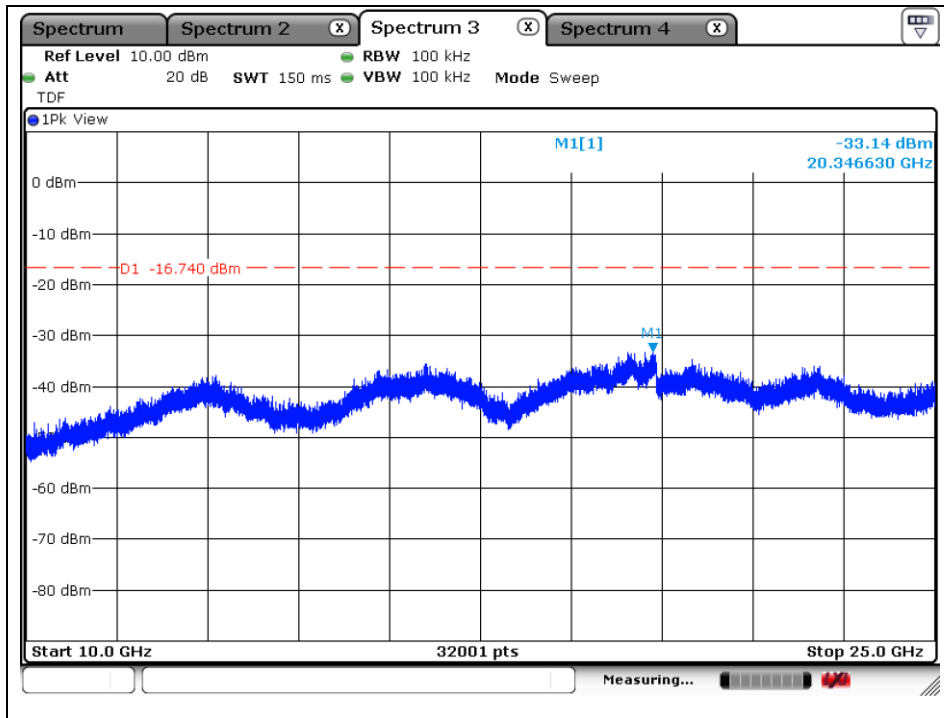
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## Operating Mode: 8DPSK (3 Mbps)

### Low Channel

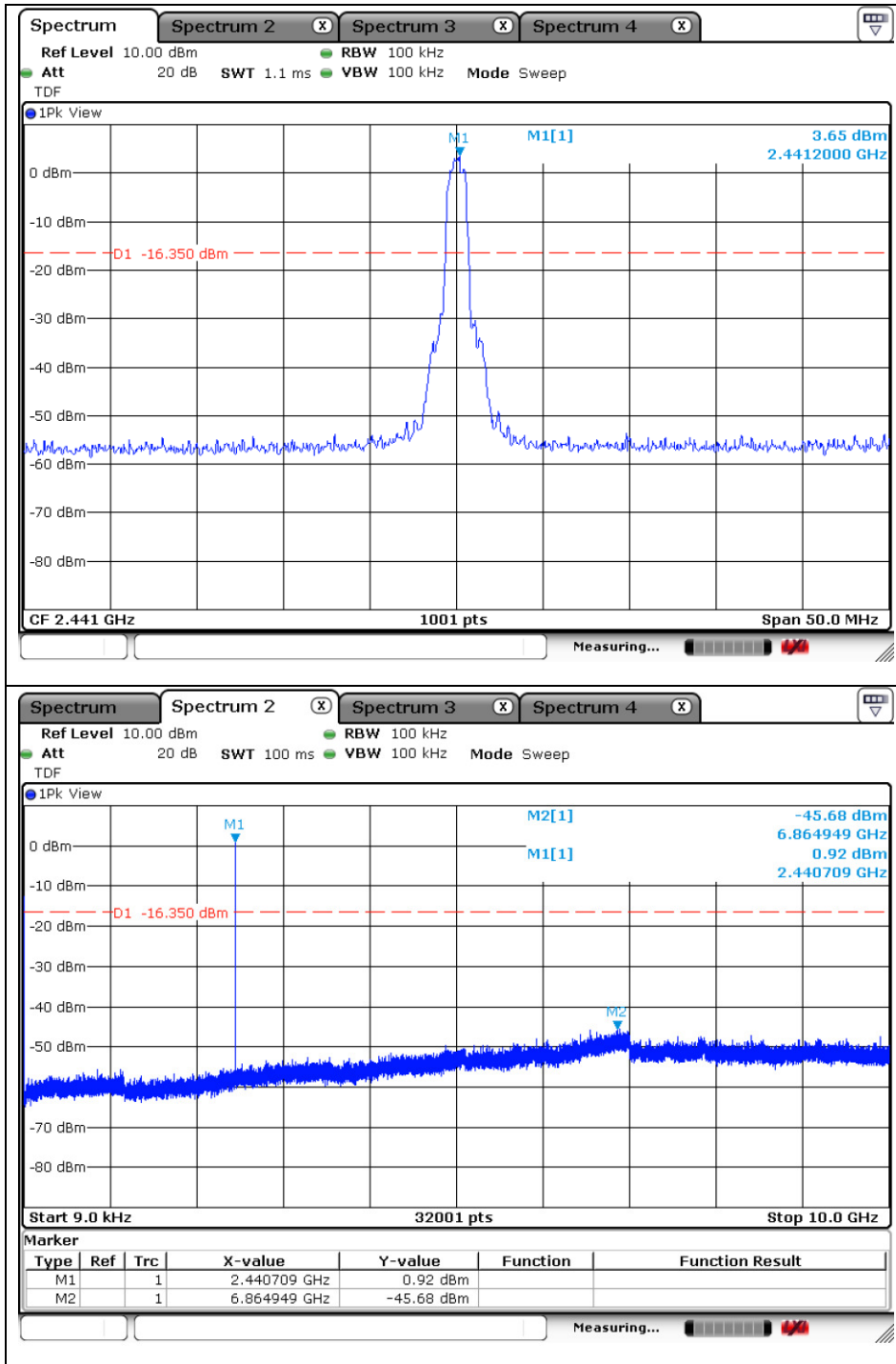


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.



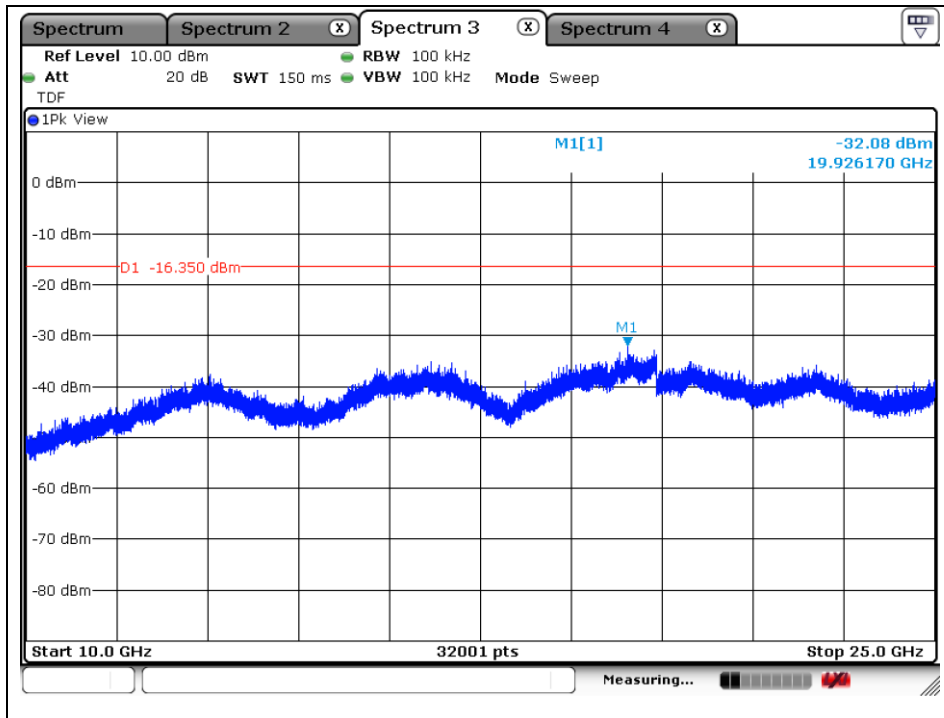
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

Middle Channel



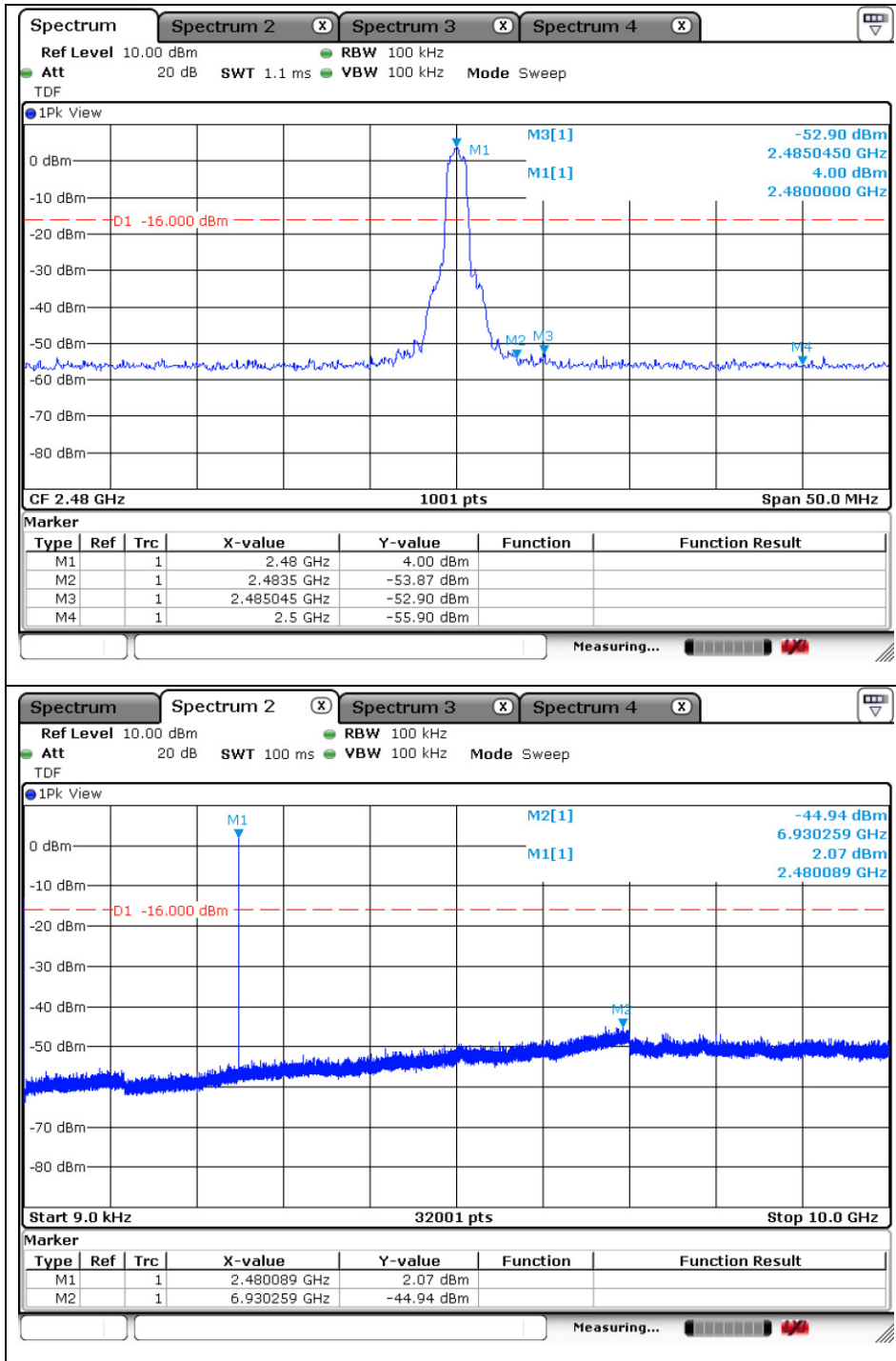
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.



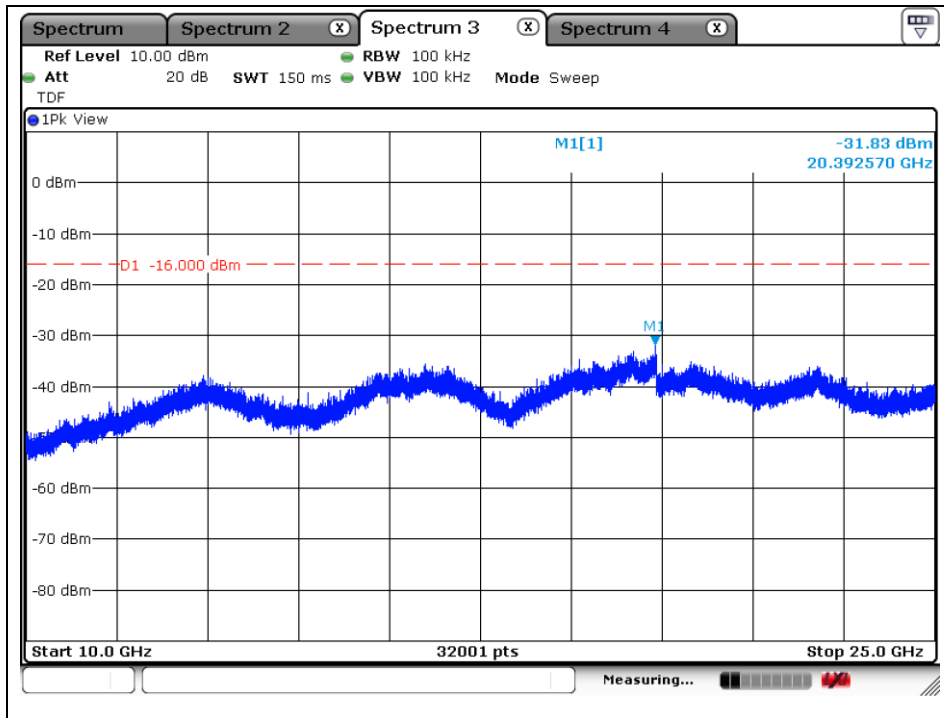


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

High Channel



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

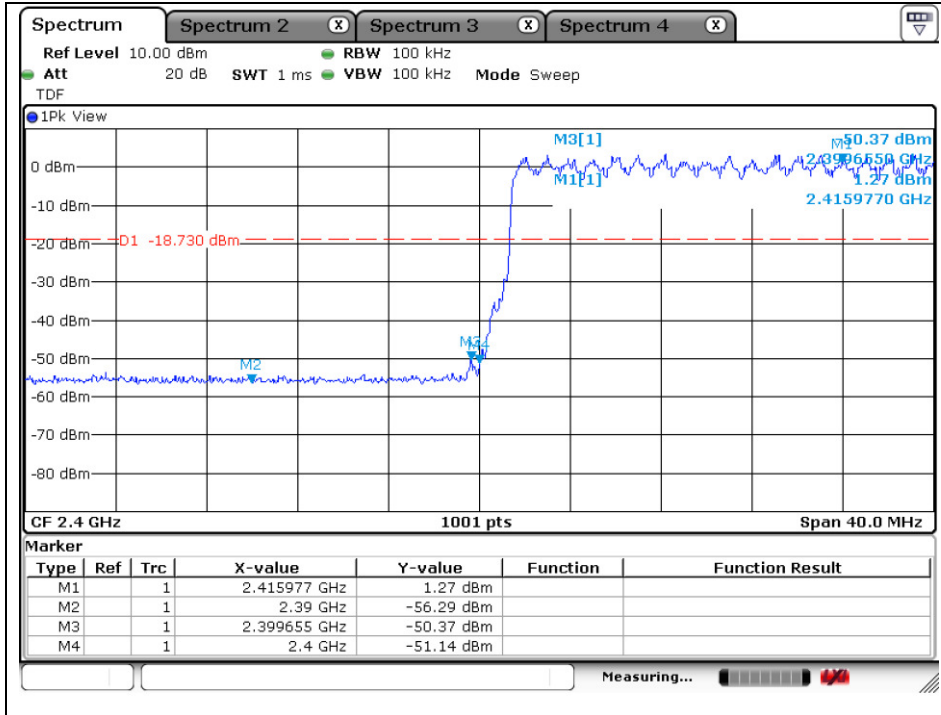


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

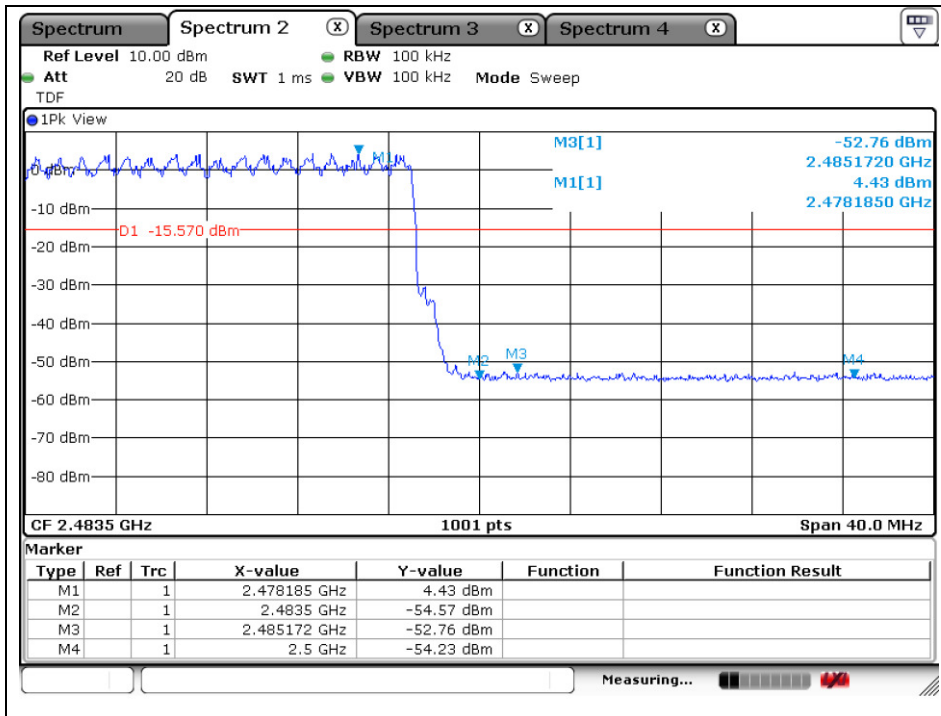
SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## Band edge Compliance with Hopping Enabled

### Low channel



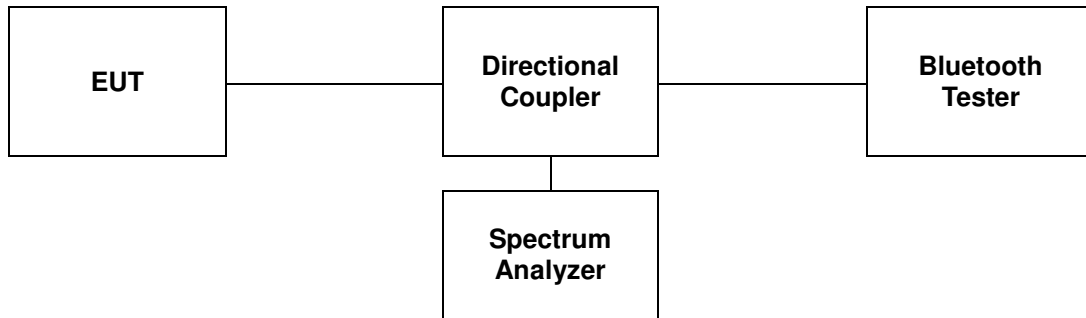
### High channel



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

### 3. 20 dB Bandwidth

#### 3.1. Test Setup



#### 3.2. Limit

Limit: Not Applicable

#### 3.3. Test Procedure

The test follows DA 00-705.

The 20 dB bandwidth was measured with a spectrum analyzer connected to RF antenna connector (conducted measurement) while EUT was operating in transmit mode at the appropriate center frequency.

Use the following spectrum analyzer setting :

Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel

RBW  $\geq$  1 % of the 20 dB bandwidth

VBW  $\geq$  RBW

Sweep = auto

Detector function = peak

Trace = max hold

Use the marker-to-peak function to set the mark to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is the 20 dB bandwidth of the emission.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)

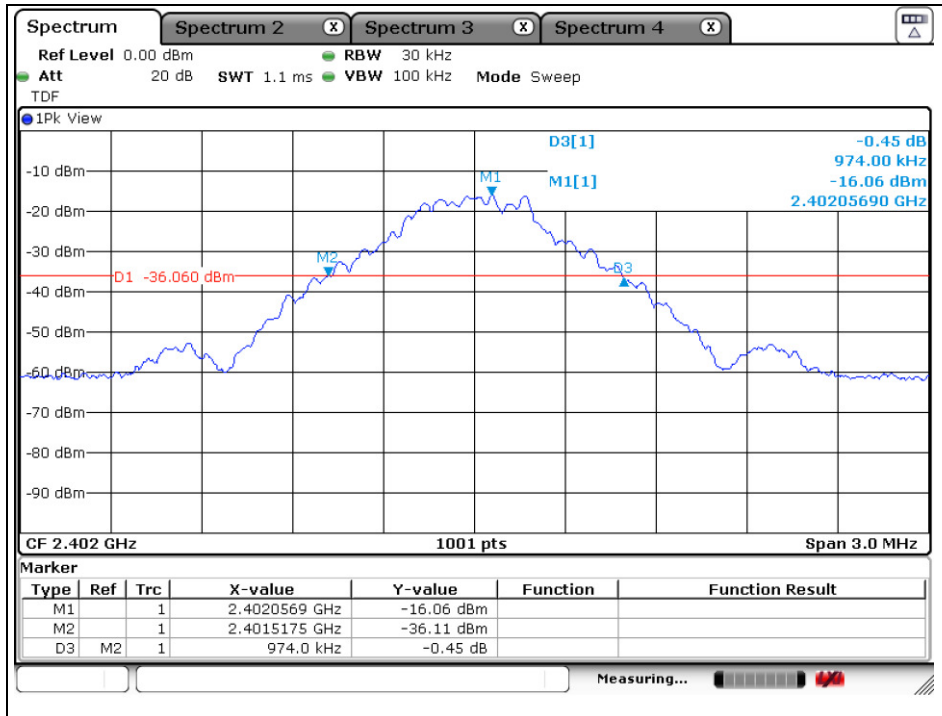
### 3.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

Operation Mode	Data Rate	Channel	Frequency (MHz)	20 dB Bandwidth (MHz)
GFSK	1 Mbps	Low	2 402	0.974
		Middle	2 441	0.962
		High	2 480	0.965
π/4DQPSK	2 Mbps	Low	2 402	1.337
		Middle	2 441	1.337
		High	2 480	1.334
8DPSK	3 Mbps	Low	2 402	1.274
		Middle	2 441	1.304
		High	2 480	1.301

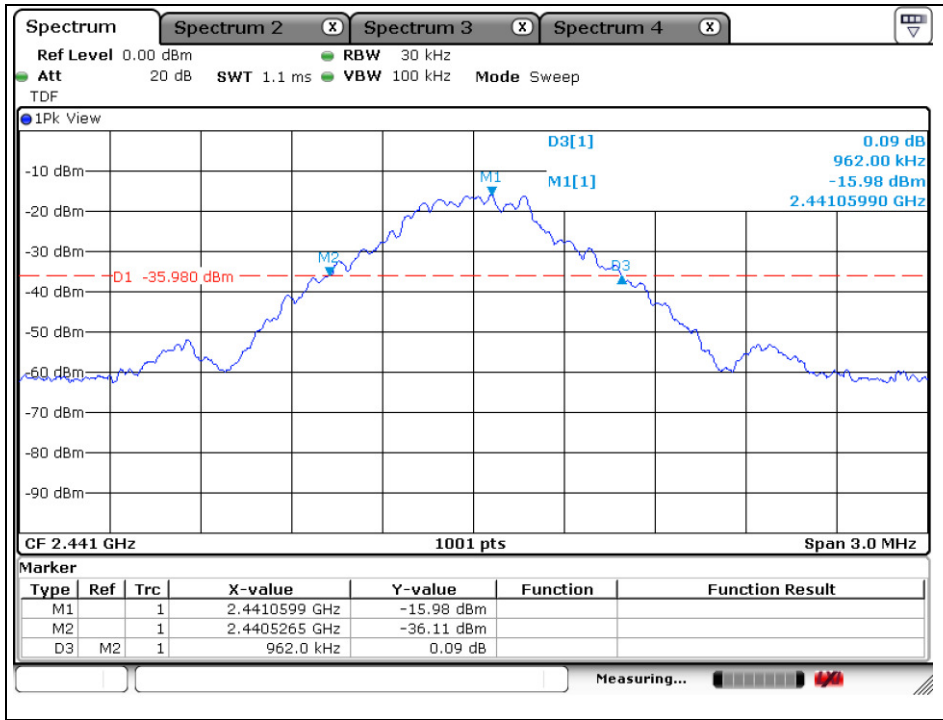
#### Operating Mode: GFSK

Low Channel

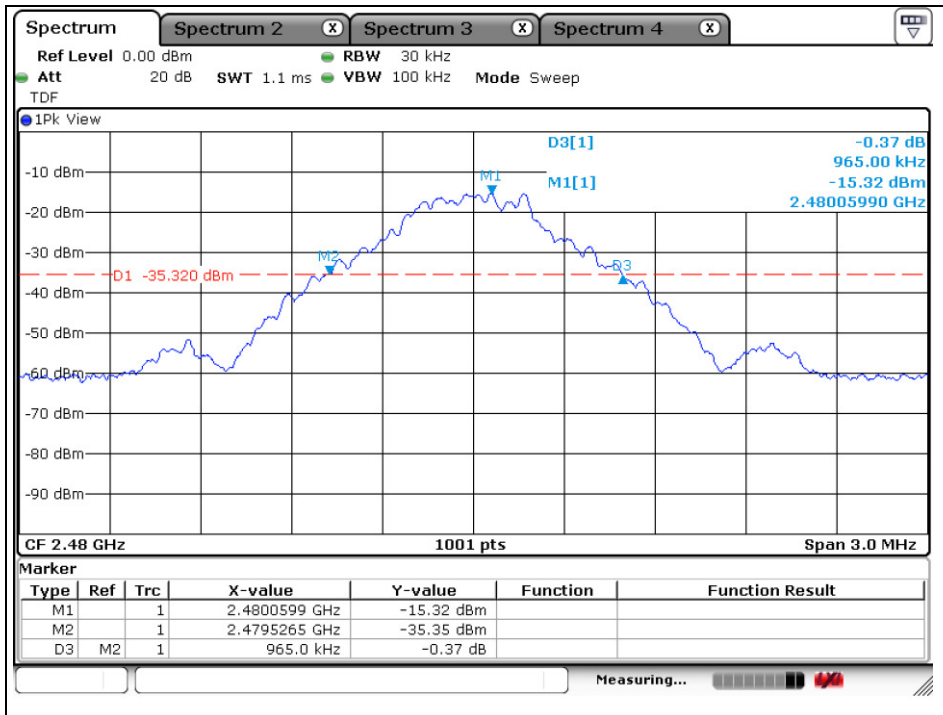


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

Middle Channel



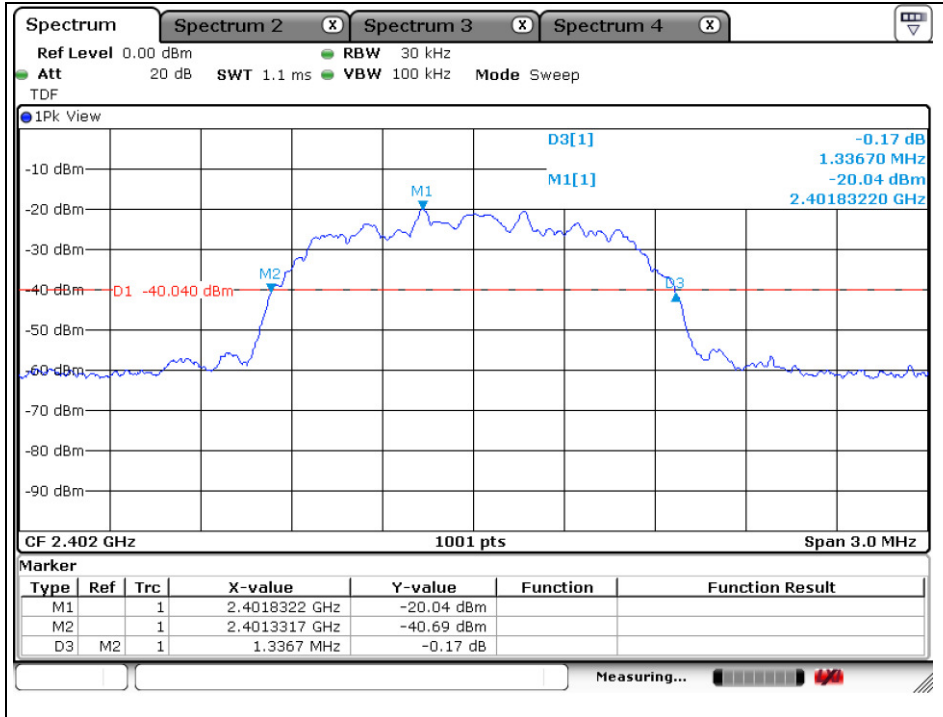
High Channel



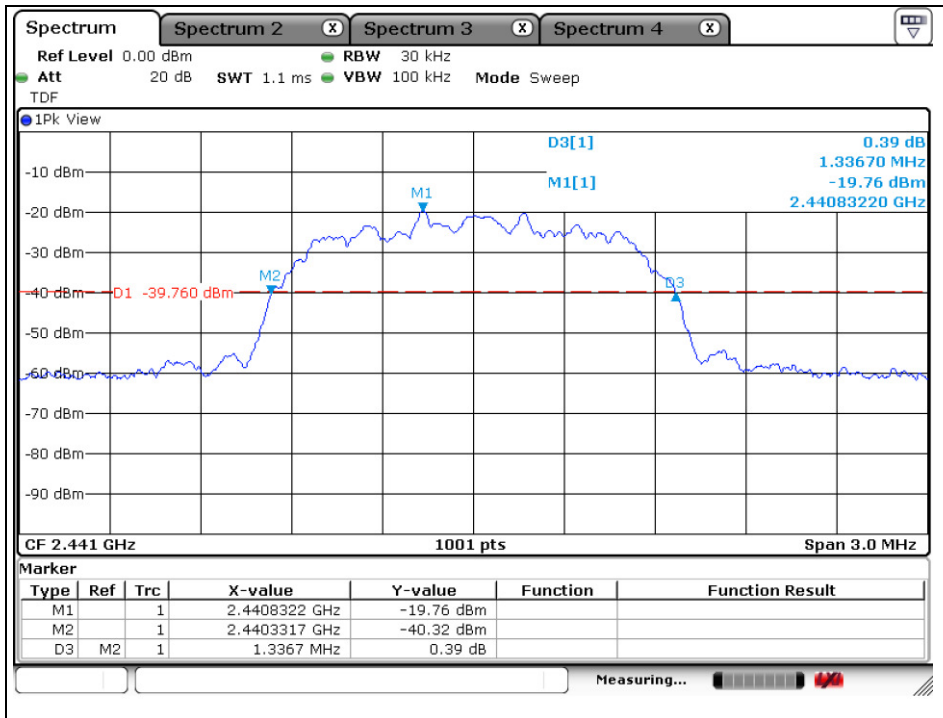
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## Operating Mode: $\pi/4$ DQPSK

### Low Channel



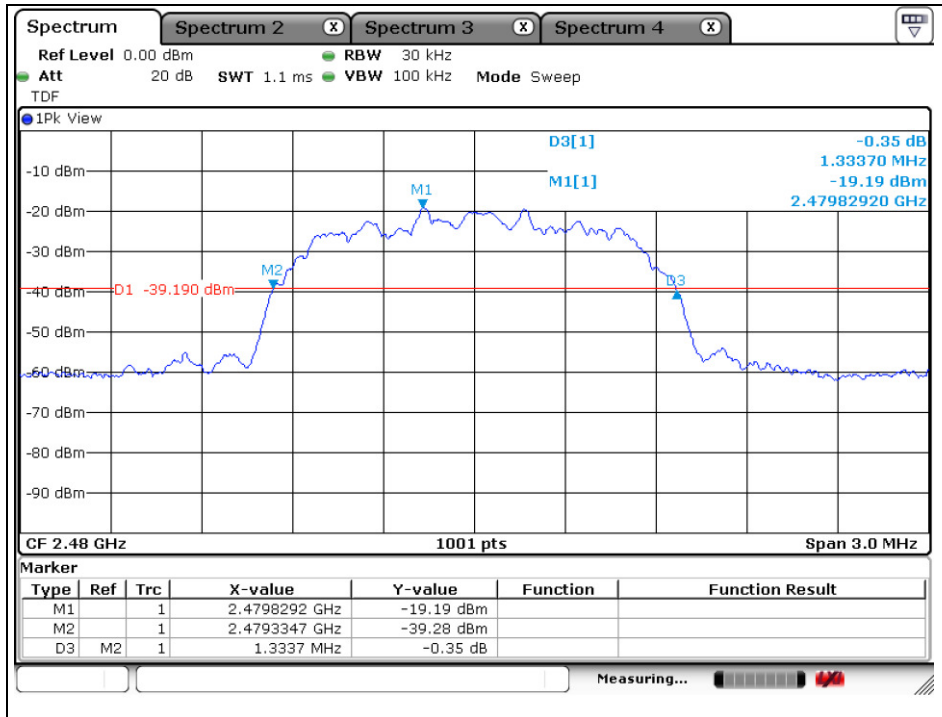
### Middle Channel



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

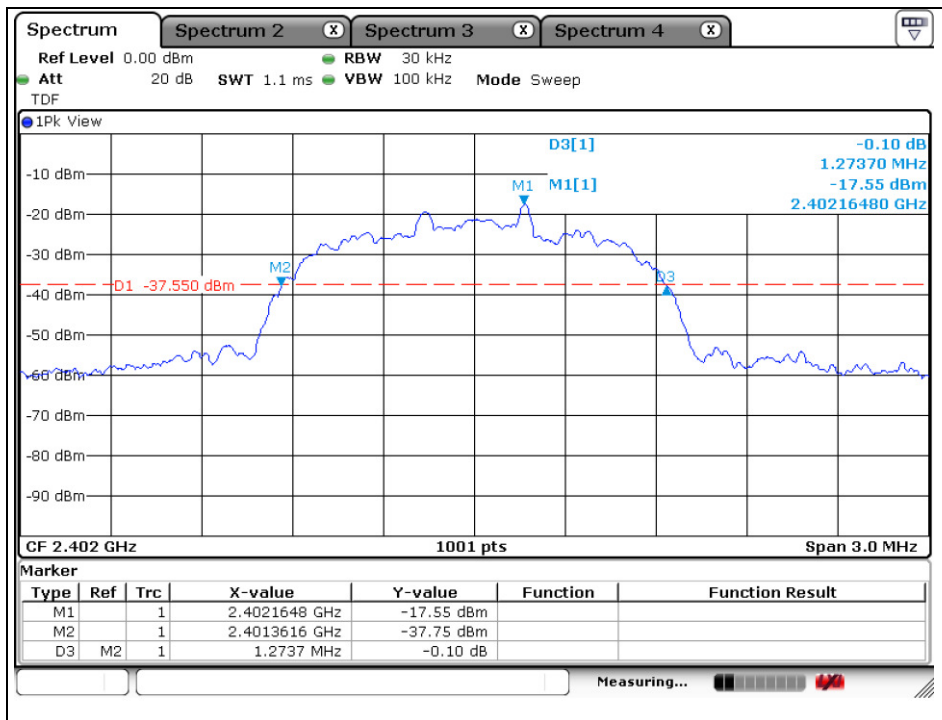


High Channel



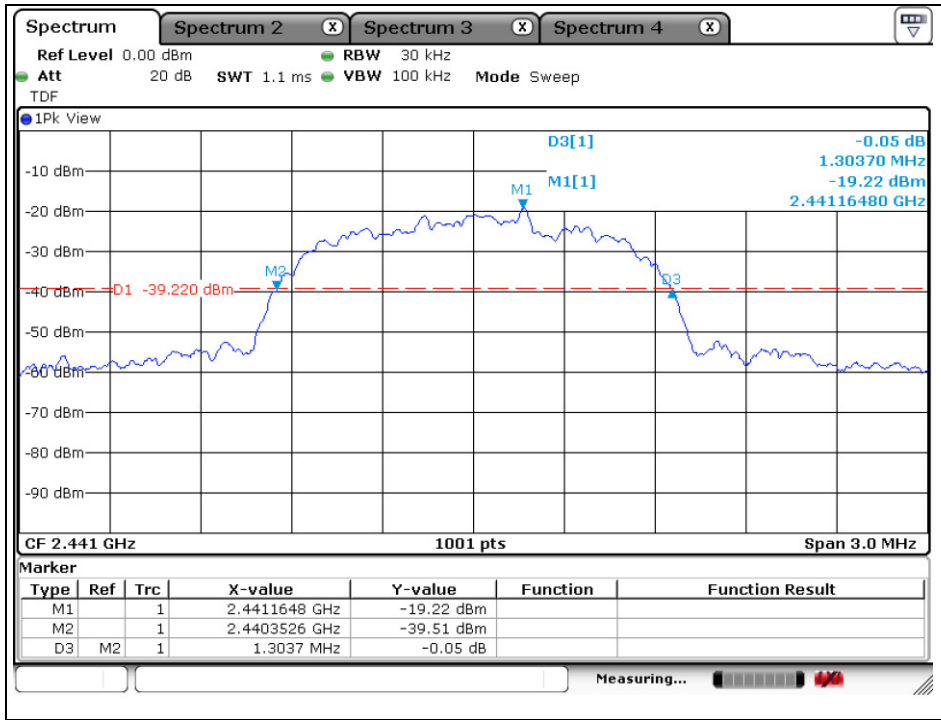
Operating Mode: 8DPSK

Low Channel

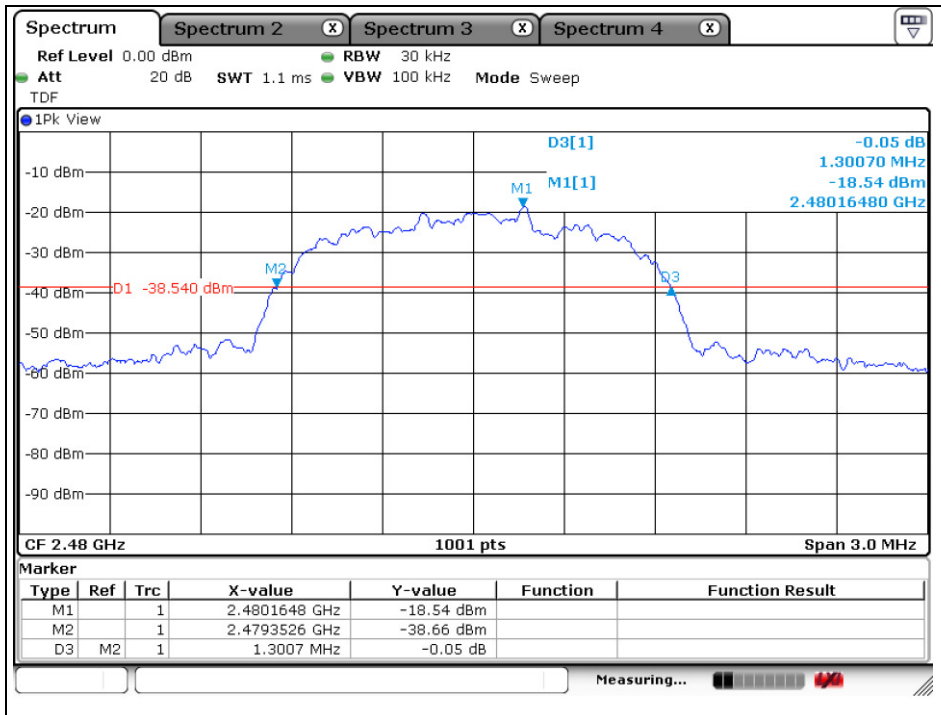


The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

Middle Channel



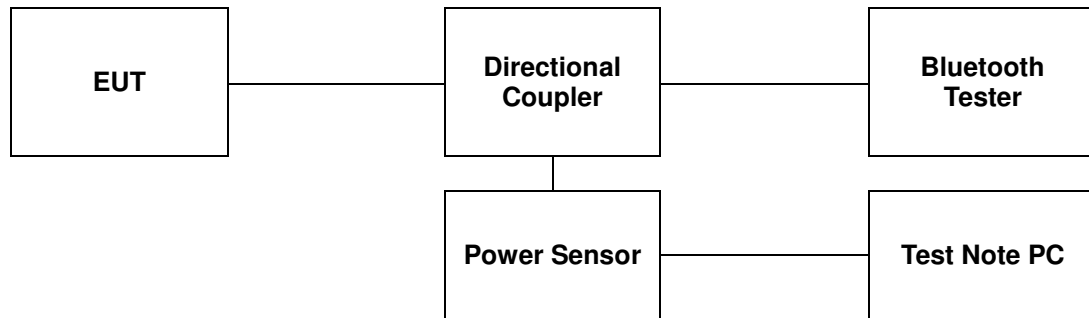
High Channel



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## 4. Maximum Peak Conducted Output Power

### 4.1. Test Setup



### 4.2. Limit

The maximum peak output power of the intentional radiator shall not exceed the following :

1. §15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
2. §15.247(b)(1), For frequency hopping systems operating in the 2 400 – 2 483.5 MHz employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5 725 – 5 805 MHz band : 1 Watt.

### 4.3. Test Procedure

The test follows DA 00-705. Using the power sensor instead of a spectrum analyzer.

1. Place the EUT on the table and set it in the transmitting mode.
2. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the Power sensor.
3. Test program : (S/W name : R&S Power Viewer, Version : 3.2.0)
4. Measure peak power each channel.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

#### 4.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

Operation Mode	Data Rate	Channel	Frequency (MHz)	Directional Coupler + Cable offset (dB)	Peak Power Result (dB m)	Peak Power Limit (dB m)
GFSK	1 Mbps	Low	2 402	15.31	<b><u>7.28</u></b>	30.00
		Middle	2 441	15.22	6.65	
		High	2 480	15.36	6.95	
π/4DQPSK	2 Mbps	Low	2 402	15.31	<b><u>8.16</u></b>	20.97
		Middle	2 441	15.22	7.54	
		High	2 480	15.36	7.82	
8DPSK	3 Mbps	Low	2 402	15.31	<b><u>8.29</u></b>	20.97
		Middle	2 441	15.22	7.63	
		High	2 480	15.36	7.91	

**Remark:**

In the case of AFH, the limit for peak power is 0.125 W

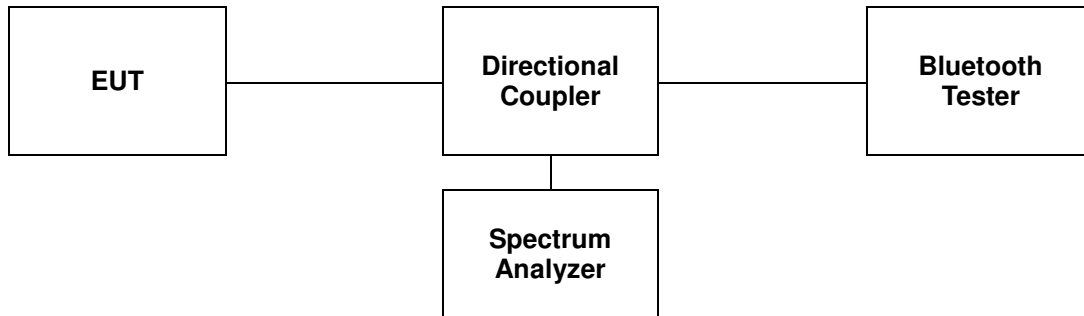
Directional coupler and cable offset compensate for test program (R&S Power Viewer) before measuring.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## 5. Carrier Frequency Separation

### 5.1. Test Setup



### 5.2. Limit

§15.247(a)(1), Frequency hopping system operating in 2 400 – 2 483.5 MHz. Band may have hopping channel carrier frequencies that are separated by 25 kHz or two-third of 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.

### 5.3. Test Procedure

All data rates and modes were investigated for this test. The full data for the worst case data rate are reported in this section. The test follows DA 00-705.

The device is operating in hopping mode between 79 channels and also supporting Adaptive Frequency Hopping with hopping between 20 channels. As compared with each operating mode, 79 channels are chosen as a representative for test.

Use the following spectrum analyzer settings:

Span = wide enough to capture the peaks of two adjacent channels  
 RBW  $\geq$  1 % of the span  
 VBW  $\geq$  RBW  
 Sweep = auto  
 Detector = peak  
 Trace = max hold

Allow the trace to stabilize. Use the marker-delta function to determine the between the peaks of the adjacent channels.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## 5.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

Operation Mode	Channel (Middle)	Adjacent Hopping Channel Separation (kHz)	Two-third of 20 dB Bandwidth (MHz)	Minimum Bandwidth (kHz)
GFSK	2 441 MHz	1 000	641	25
8DPSK	2 441 MHz	1 000	869	25

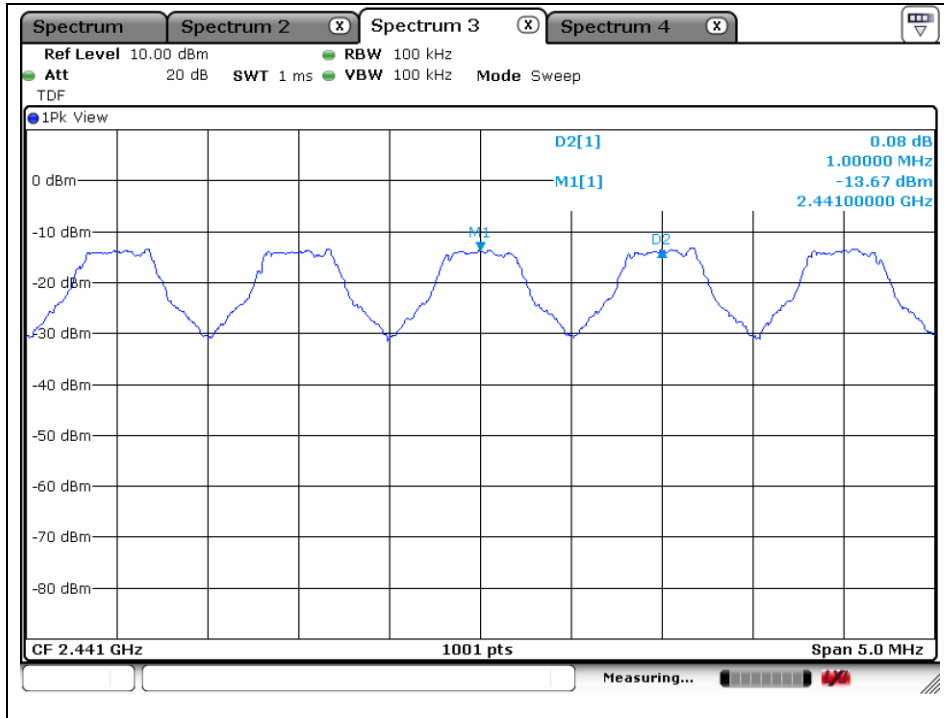
Note;

Measurement is made with EUT operating in hopping mode between 79 channels providing a worse case scenario as compared to AFH mode hopping between 20 channels.

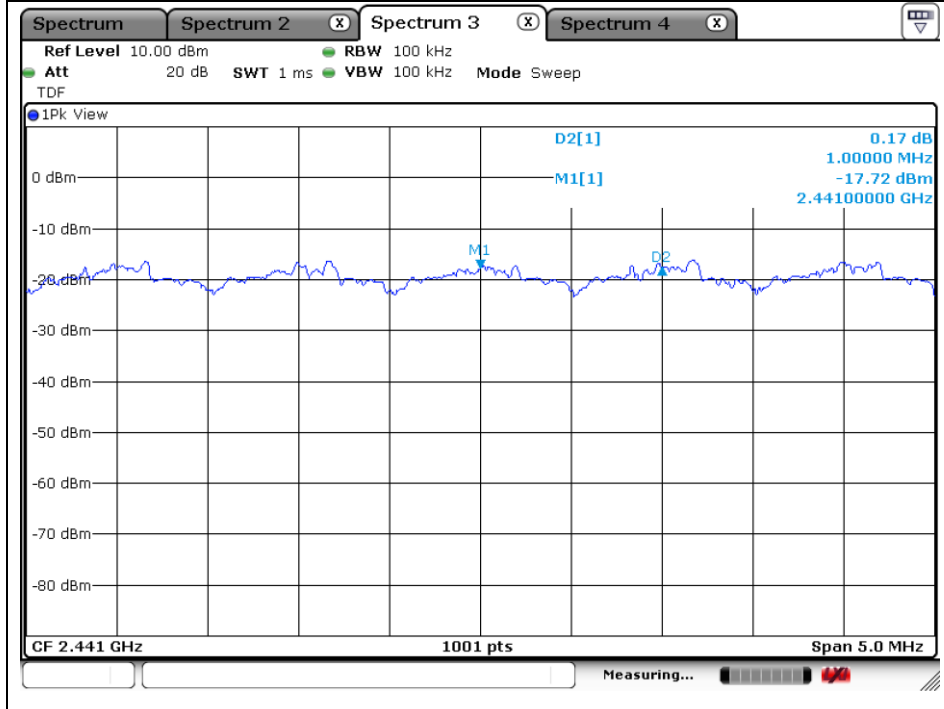
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

### Operating Mode: GFSK



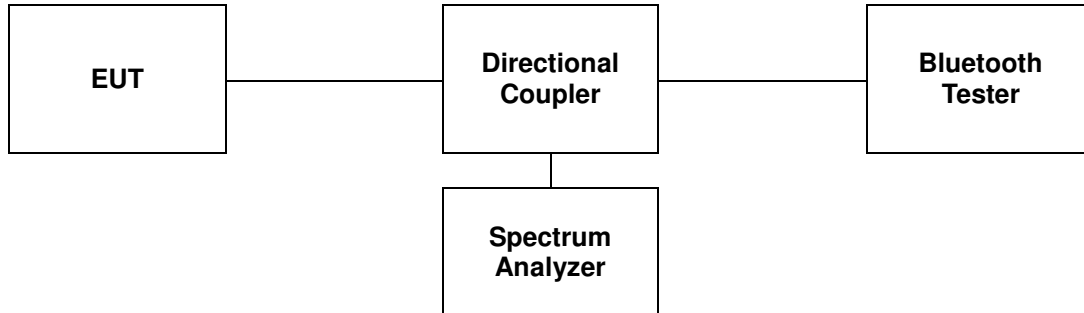
### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## 6. Number of Hopping Frequencies

### 6.1. Test Setup



### 6.2. Limit

§15.247(a)(1)(iii), Frequency hopping systems in the 2 400–2 483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

### 6.3. Test Procedure

All data rates and modes were investigated for this test. The full data for the worst case data rate are reported in this section. The test follows DA 00-705.

The device supports Adaptive Frequency Hopping and will use a minimum of 20 channels of the 79 available channels.

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

1. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna the port to the Spectrum analyzer.
2. Set spectrum analyzer Start = 2 400 MHz, Stop = 2 441.5 MHz, Sweep = auto and Start = 2 441.5 MHz, Stop = 2 483.5 MHz, Sweep = auto. Detector = peak.
3. Set the spectrum analyzer as RBW, VBW = 500 kHz.
4. Max hold, allow the trace to stabilize and count how many channel in the band.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>



## 6.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

Operation Mode	Number of Hopping Frequency	Limit
GFSK	79	≥ 15
8DPSK	79	≥ 15

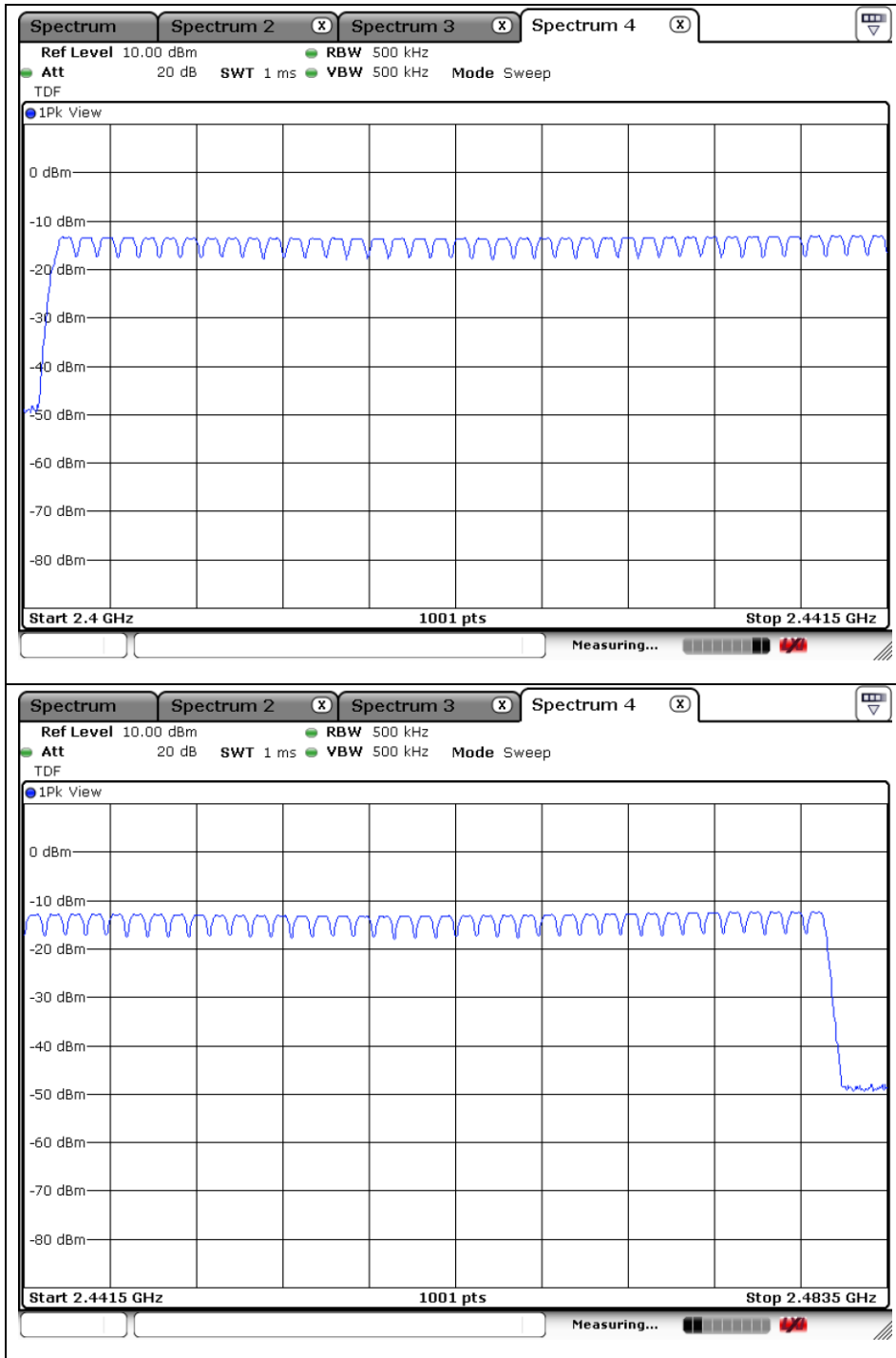
**Remark:**

Measurement is made with EUT operating in hopping mode between 79 channels providing a worse case scenario as compared to AFH mode hopping between 20 channels.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

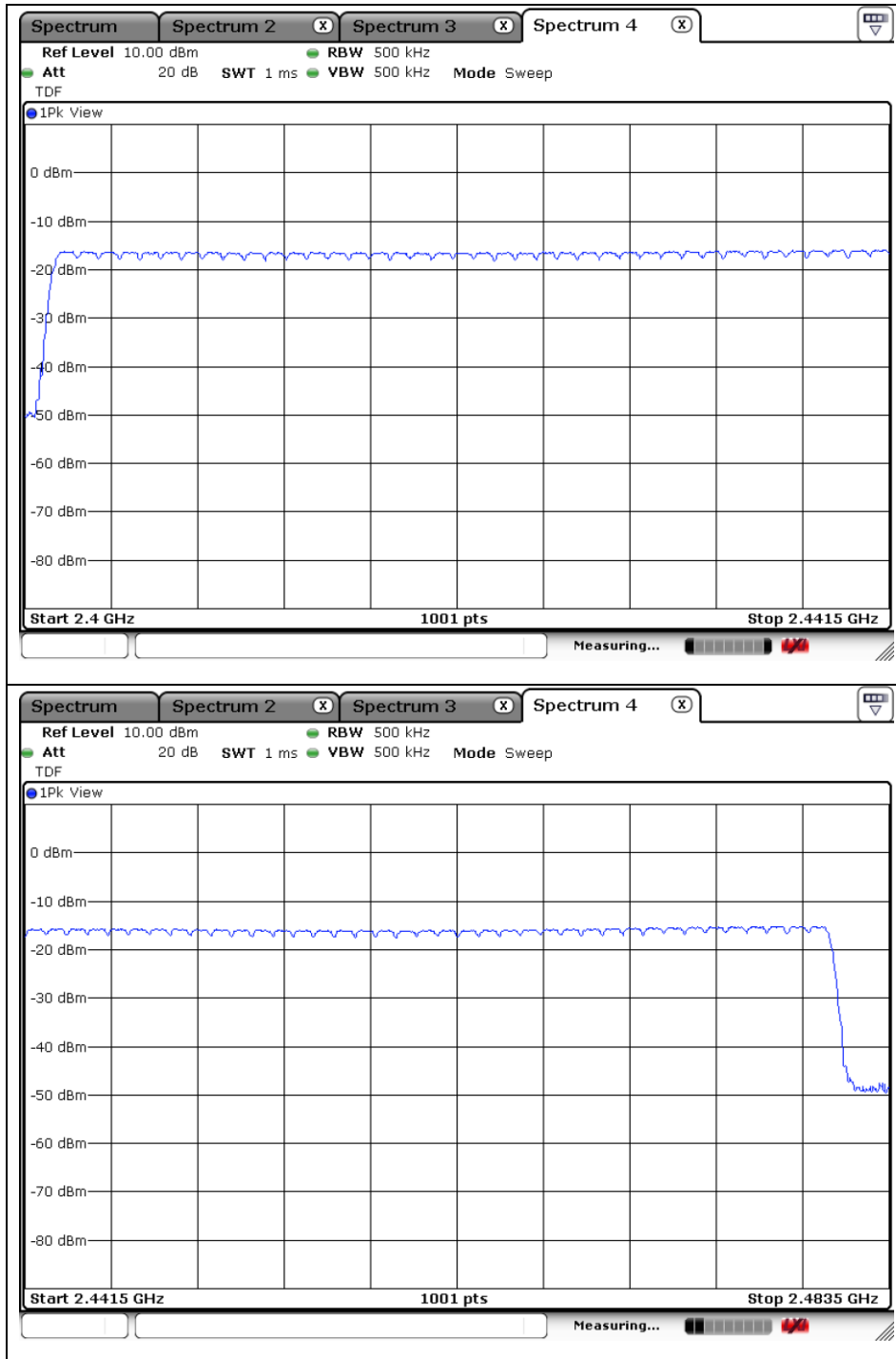
**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

**Operating Mode: GFSK**



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

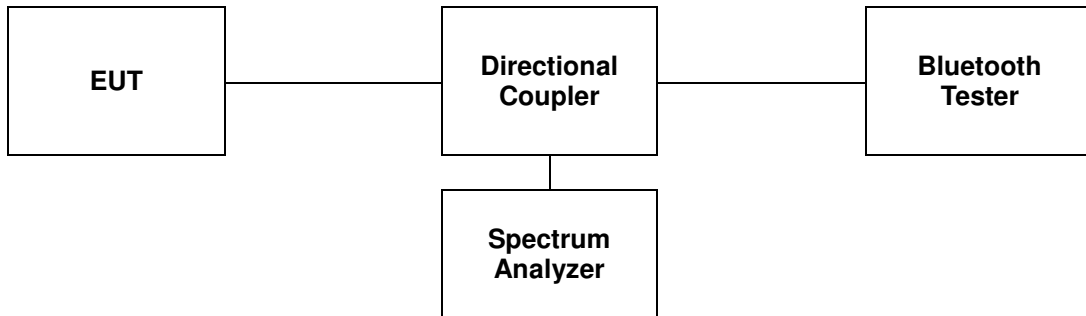
**Operating Mode : 8DPSK**



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

## 7. Time of Occupancy (Dwell Time)

### 7.1. Test Set up



### 7.2. Limit

§15.247(a)(1)(iii), For frequency hopping system operating in the 2 400 – 2 483.5 MHz band, the average time of occupancy on any frequency shall not be greater than 0.4 second within a 31.6 second period.

A period time = 0.4 (s) \* 79 = 31.6 (s)

#### \*Adaptive Frequency Hopping

A period time = 0.4 (s) \* 20 = 8 (s)

### 7.3. Test Procedure

All data rates and modes were investigated for this test. The full data for the worst case data rate are reported in this section. The test follows DA 00-705.

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT as shown in test setup without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable.
3. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
4. The Bluetooth has 3 type of payload, DH1, DH3, DH5 and 3DH1, 3DH3, 3DH5. The hopping rate is insisted of 1 600 per second.

The EUT must have its hopping function enabled. Use the following spectrum analyzer setting:

Span = zero span, centered on a hopping channel

RBW = 1 MHz

VBW ≥ RBW

Sweep = as necessary to capture the entire dwell time per hopping channel

Detector = peak

Trace = max hold

Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation, repeat this test for each variation.

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)

## 7.4. Test Results

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.

### 7.4.1. Packet Type: DH1, 3DH1

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 31.6 sec (ms)	Limit for time of occupancy on the Tx Channel in 31.6 sec (ms)
GFSK	2 441 MHz	0.38	121.60	400
8DPSK	2 441 MHz	0.38	121.60	400

Note:

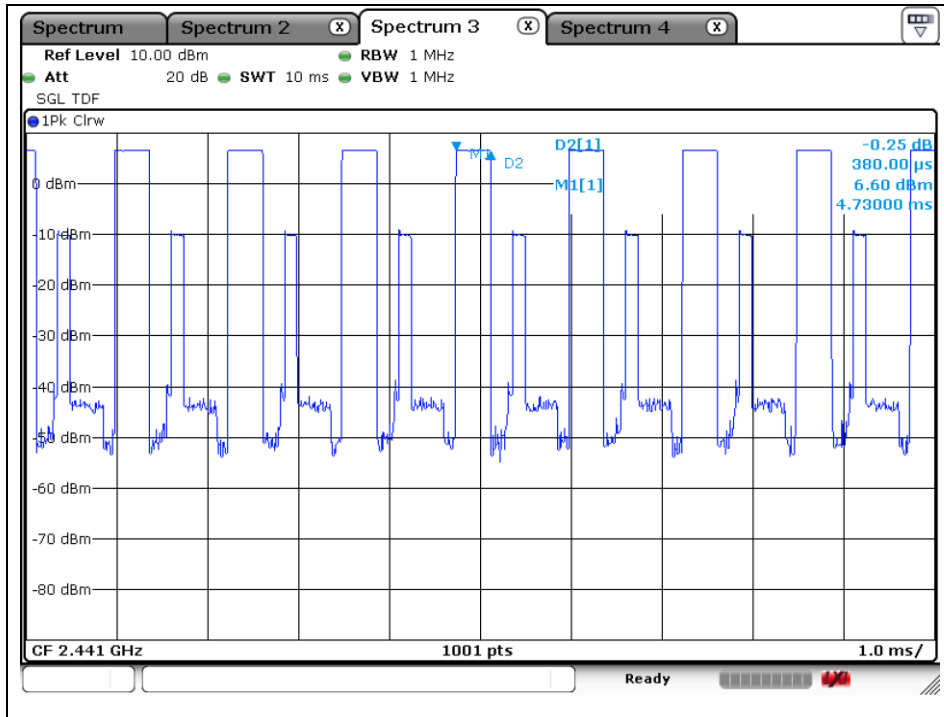
Time of occupancy on the TX channel in 31.6 sec

In case of GFSK and 8DPSK,  $0.38 \times \{(1\ 600 \div 2) / 79\} \times 31.6 = 121.60$  ms

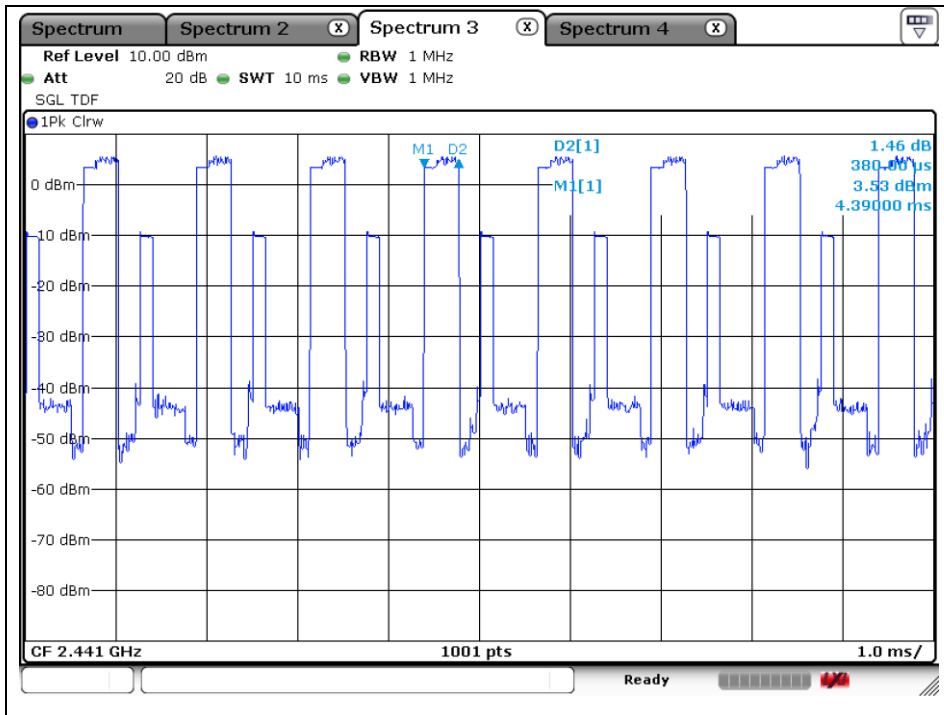
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

### Operating Mode: GFSK



### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

**7.4.2. Packet Type: DH3, 3DH3**

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 31.6 sec (ms)	Limit for time of occupancy on the Tx Channel in 31.6 sec (ms)
GFSK	2 441 MHz	1.64	262.40	400
8DPSK	2 441 MHz	1.64	262.40	400

**Note:**

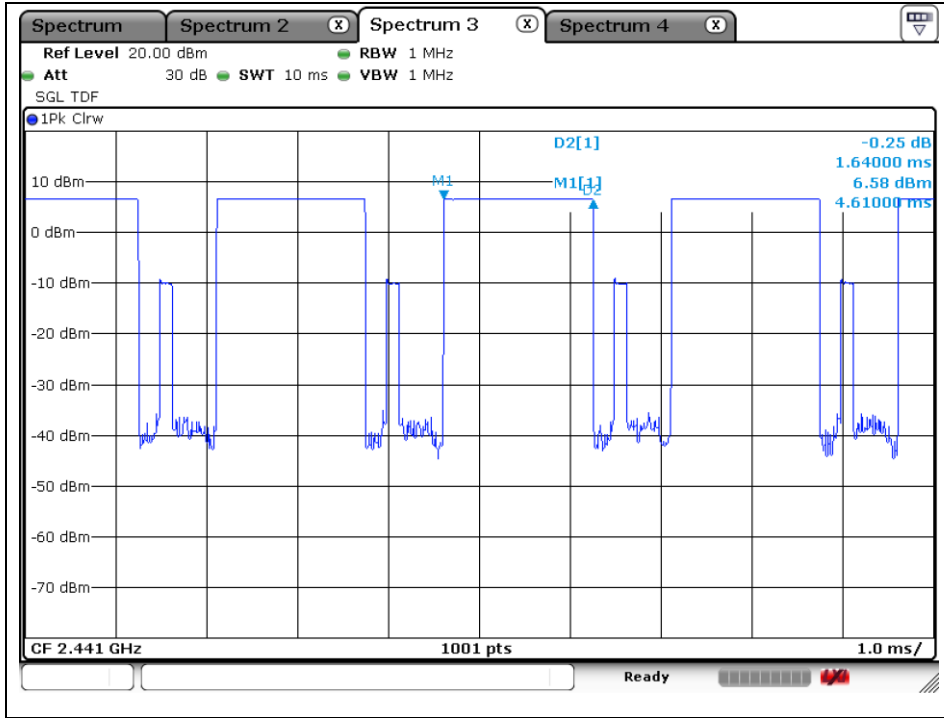
Time of occupancy on the TX channel in 31.6 sec

 In case of GFSK and 8DPSK,  $1.64 \times \{(1\ 600 \div 4) / 79\} \times 31.6 = 262.40$  ms

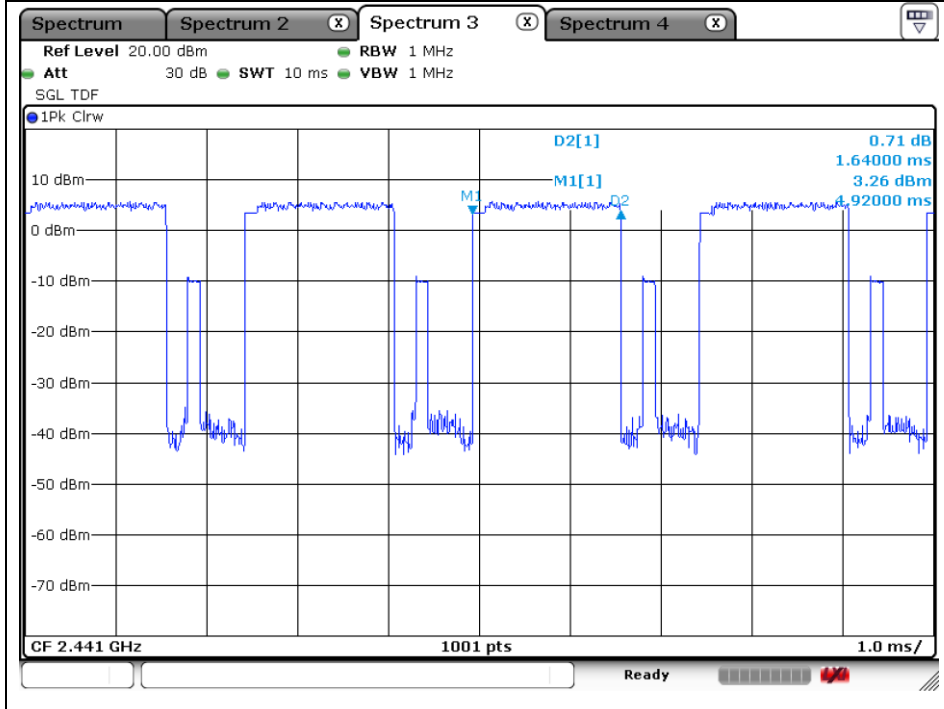
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

### Operating Mode: GFSK



### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.



**7.4.3. Packet Type: DH5, 3DH5**

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 31.6 sec (ms)	Limit for time of occupancy on the Tx Channel in 31.6 sec (ms)
GFSK	2 441 MHz	2.89	308.27	400
8DPSK	2 441 MHz	2.89	308.27	400

**Note:**

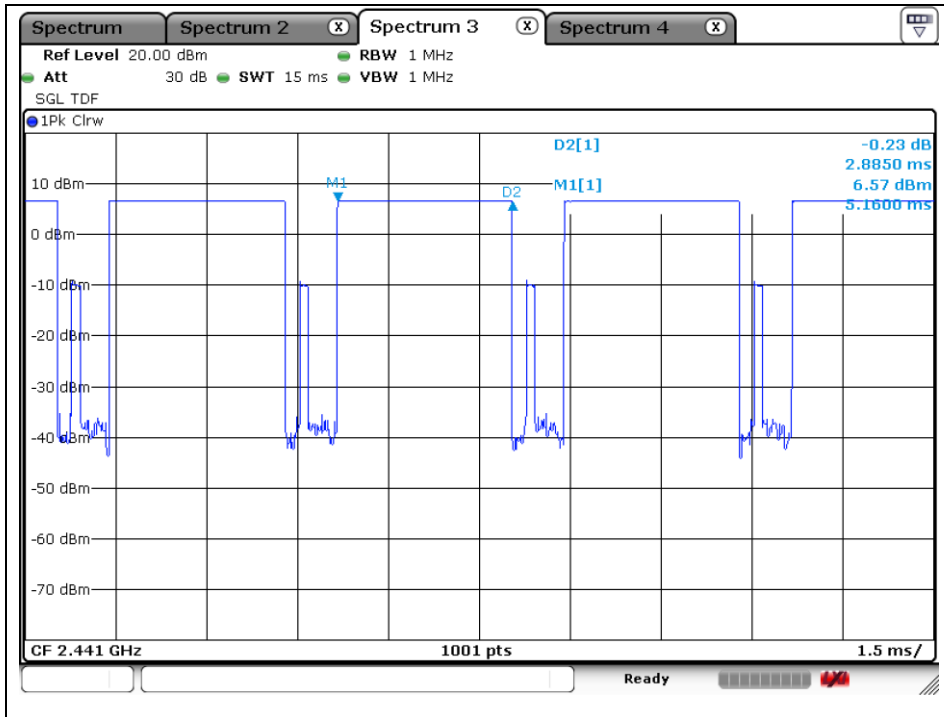
Time of occupancy on the TX channel in 31.6 sec

 In case of GFSK and 8DPSK,  $2.89 \times \{(1\ 600 \div 6) / 79\} \times 31.6 = 308.27$  ms

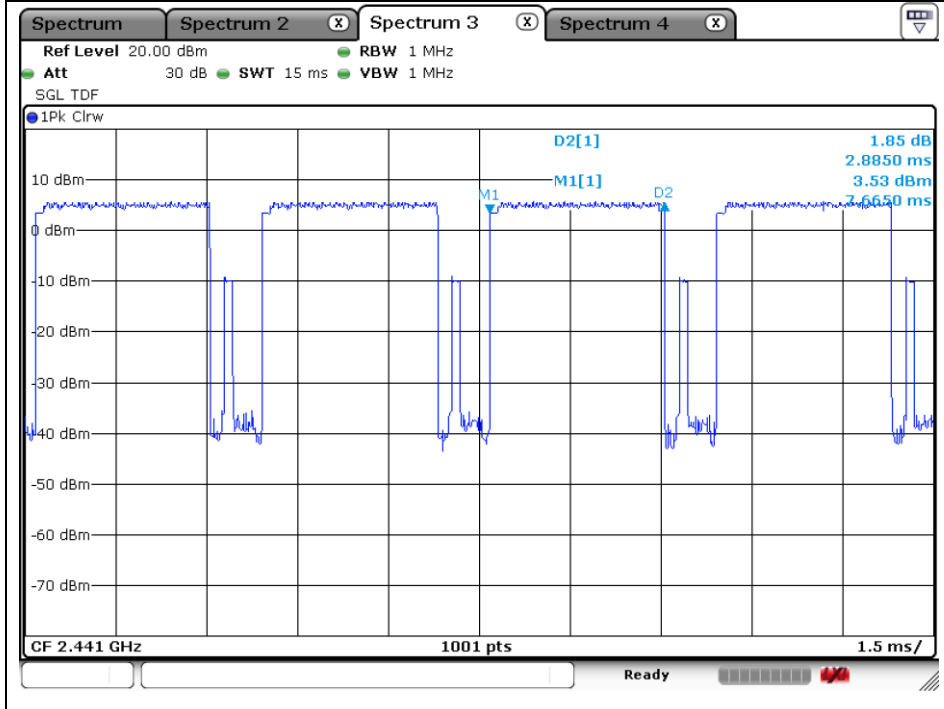
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

### Operating Mode: GFSK



### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

#### 7.4.4. Packet Type: DH1, 3DH1 (Adaptive Frequency Hopping)

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 8 sec (ms)	Limit for time of occupancy on the Tx Channel in 8 sec (ms)
GFSK	2 441 MHz	0.38	60.80	400
8DPSK	2 441 MHz	0.39	62.40	400

Note:

Time of occupancy on the TX channel in 8 sec

In case of GFSK,  $0.38 \times \{(800 \div 2) / 20\} \times 8 = 60.80$  ms

In case of 8DPSK,  $0.39 \times \{(800 \div 2) / 20\} \times 8 = 62.40$  ms

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

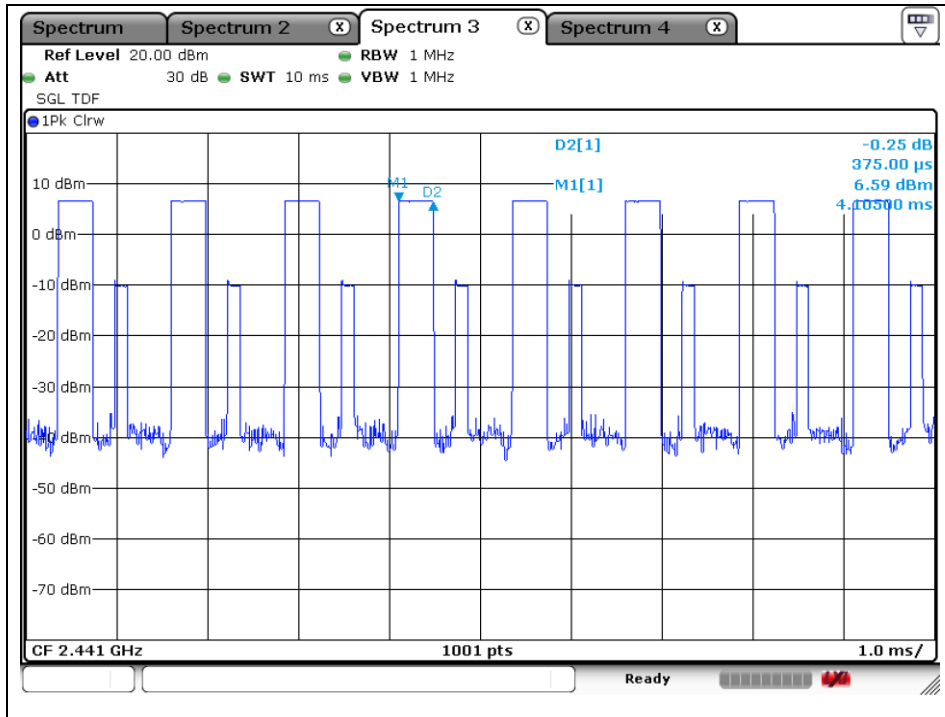
**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

RTT5041-20(2015.10.01)(3)

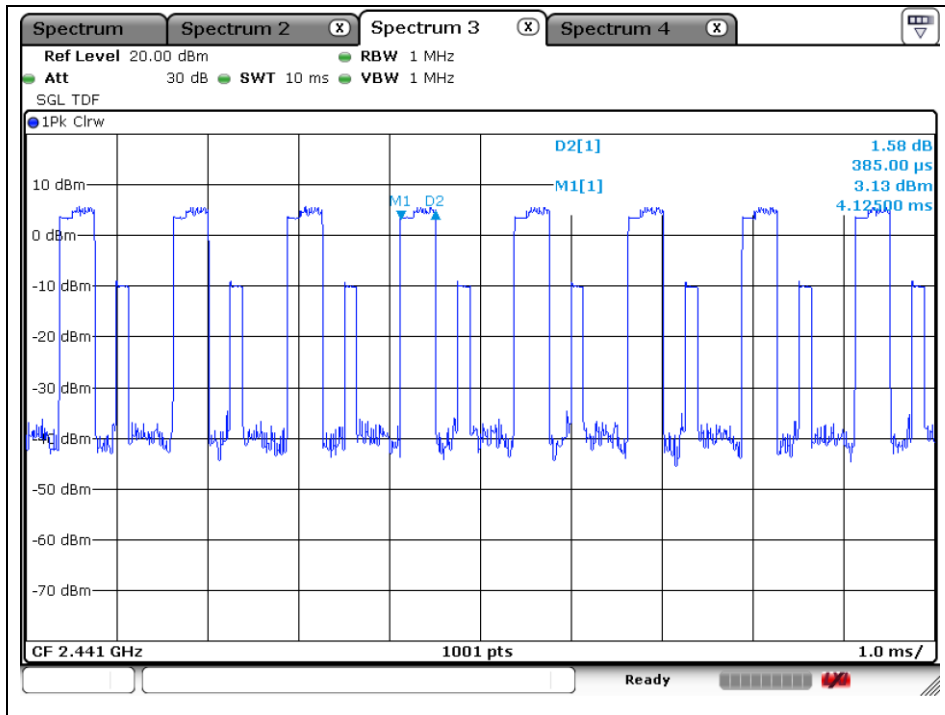
Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)

### Operating Mode: GFSK



### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

**7.4.5. Packet Type: DH3, 3DH3 (Adaptive Frequency Hopping)**

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 8 sec (ms)	Limit for time of occupancy on the Tx Channel in 8 sec (ms)
GFSK	2 441 MHz	1.64	131.20	400
8DPSK	2 441 MHz	1.64	131.20	400

**Note:**

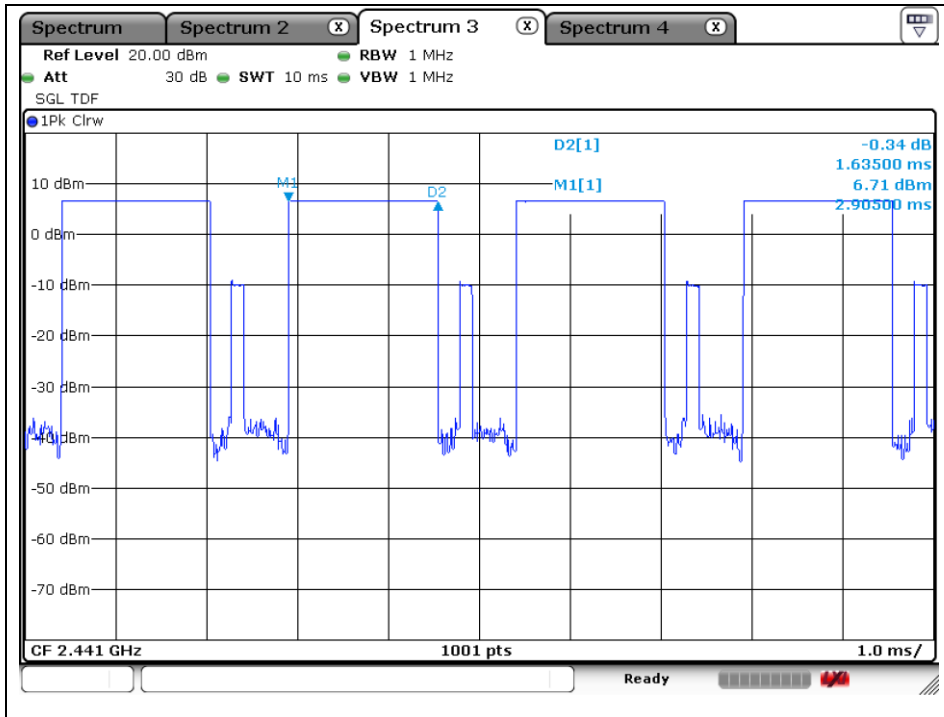
Time of occupancy on the TX channel in 8 sec

 In case of GFSK and 8DPSK,  $1.64 \times \{(800 \div 4) / 20\} \times 8 = 131.20$  ms

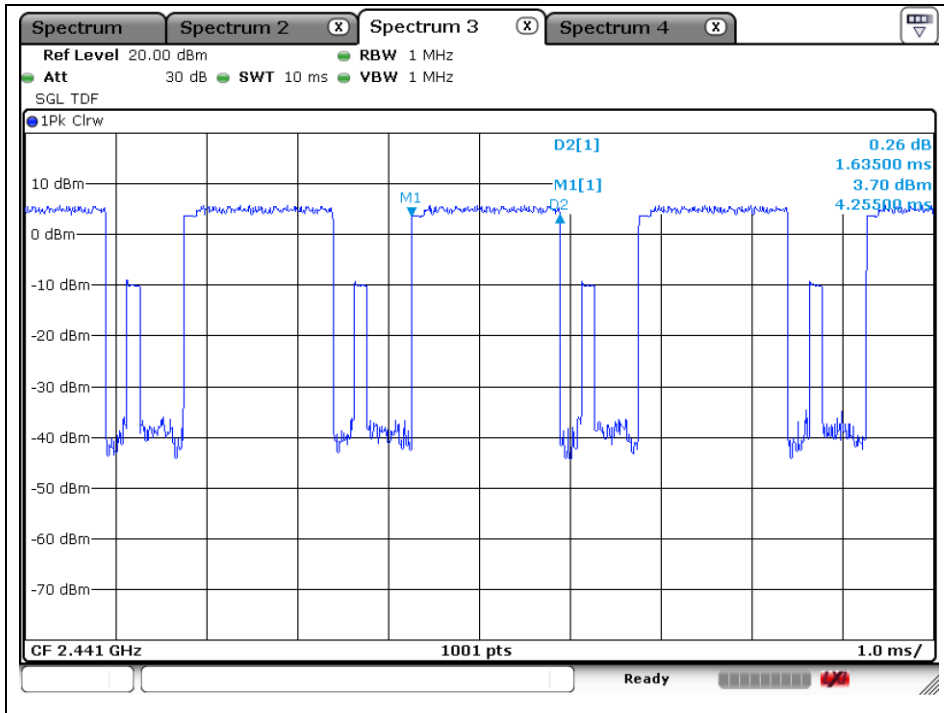
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

### Operating Mode: GFSK



### Operating Mode: 8DPSK



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsaroup.kr>

**7.4.6. Packet Type: DH5, 3DH5 (Adaptive Frequency Hopping)**

Operation Mode	Frequency	Dwell Time (ms)	Time of occupancy on the Tx Channel in 8 sec (ms)	Limit for time of occupancy on the Tx Channel in 8 sec (ms)
GFSK	2 441 MHz	2.89	154.13	400
8DPSK	2 441 MHz	2.86	152.53	400

**Note:**

Time of occupancy on the TX channel in 8 sec

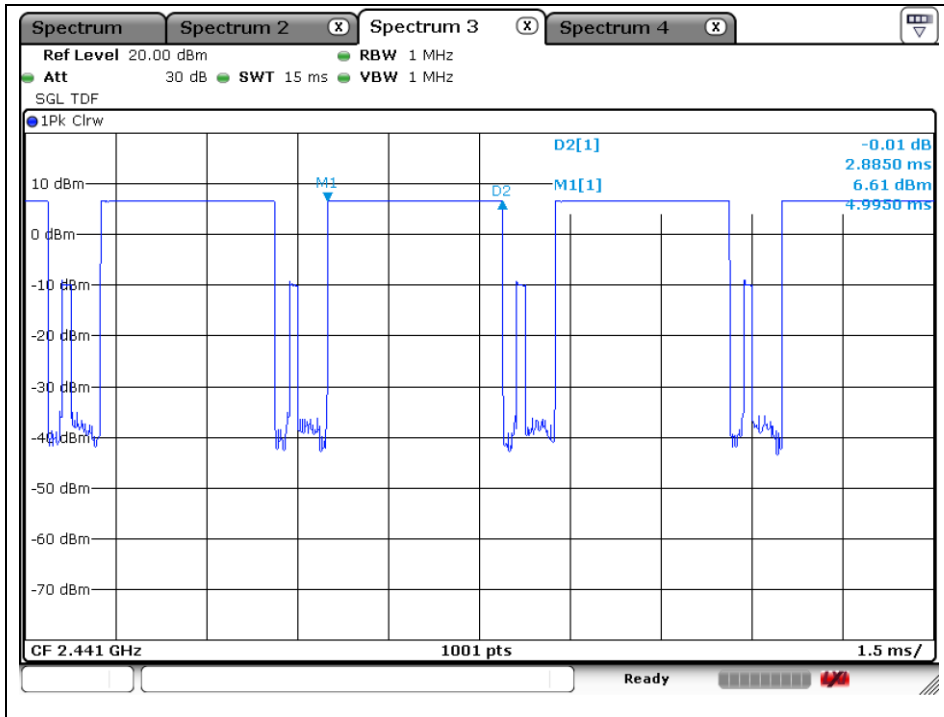
 In case of GFSK,  $2.89 \times \{(800 \div 6) / 20\} \times 8 = 154.13$  ms

 In case of 8DPSK,  $2.86 \times \{(800 \div 6) / 20\} \times 8 = 152.53$  ms

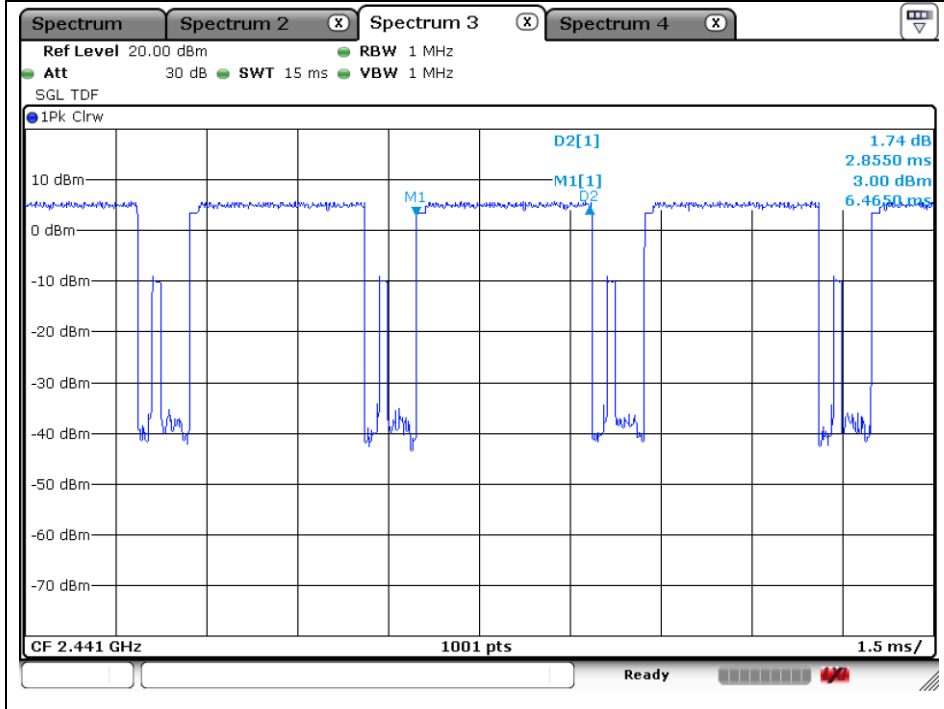
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

## Operating Mode: GFSK



## Operating Mode: 8DPSK



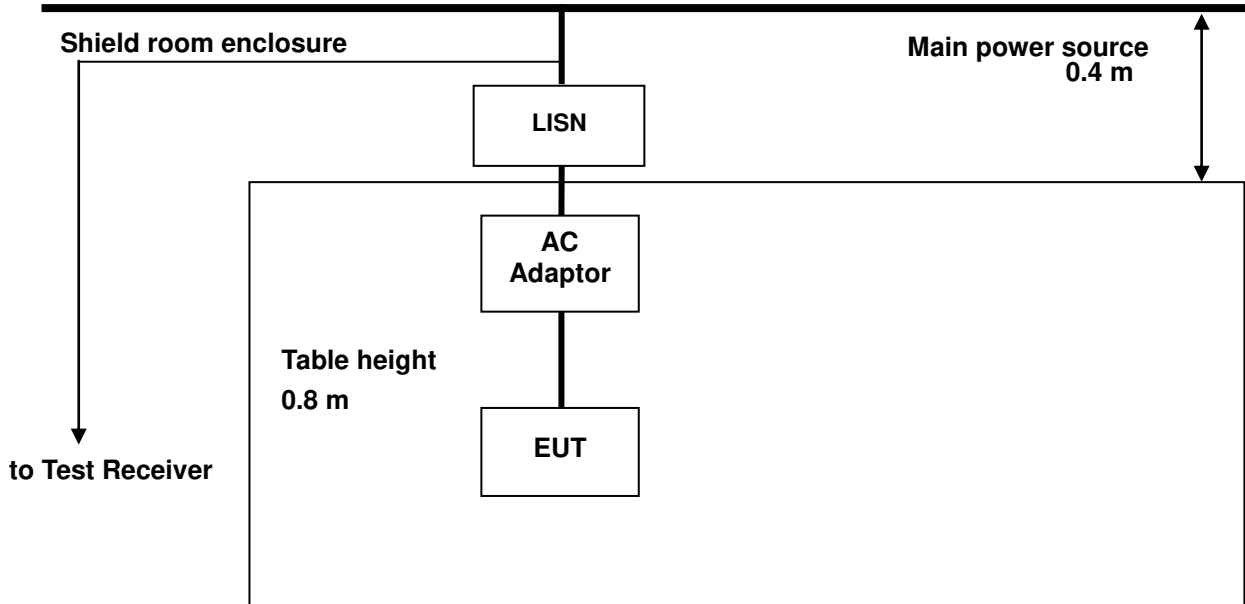
The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>



## 8. AC Power Line Conducted Emission

### 8.1. Test Setup



### 8.2. Limit

According to §15.207(a) for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50  $\mu$ H / 50 ohm line impedance stabilization network (LISN).

Compliance with the provision of this paragraph shall be on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower applies at the boundary between the frequency ranges.

Frequency of Emission (MHz)	Conducted limit (dB $\mu$ V)	
	Quasi-peak	Average
0.15 – 0.50	66 - 56*	56 - 46*
0.50 – 5.00	56	46
5.00 – 30.0	60	50

\* Decreases with the logarithm of the frequency.

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

SGS Korea Co., Ltd. (Gunpo Laboratory) 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

---

### 8.3. Test Procedures

All data rates and modes were investigated for this test. The full data for the worst case data rate are reported in this section.

AC line conducted emissions from the EUT were measured according to the dictates of ANSI C63.10-2013

1. The test procedure is performed in a 6.5 m × 3.6 m × 3.6 m (L × W × H) shielded room. The EUT along with its peripherals were placed on a 1.0 m (W) × 1.5 m (L) and 0.8 m in height wooden table and the EUT was adjusted to maintain a 0.4 meter space from a vertical reference plane.
2. The EUT was connected to power mains through a line impedance stabilization network (LISN) which provides 50 ohm coupling impedance for measuring instrument and the chassis ground was bounded to the horizontal ground plane of shielded room.
3. The excess power cable between the EUT and the LISN was bundled. All connecting cables of EUT were moved to find the maximum emission.

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm × 297 mm)

## 8.4. Test Results

The following table shows the highest levels of conducted emissions on both phase of Hot and Neutral line

Ambient temperature : (23 ± 1) °C  
 Relative humidity : 47 % R.H.  
 Frequency range : 0.15 MHz – 30 MHz  
 Measured Bandwidth : 9 kHz

FREQ. (MHz)	LEVEL(dB $\mu$ V)		LINE	LIMIT(dB $\mu$ V)		MARGIN(dB)	
	Q-Peak	Average		Q-Peak	Average	Q-Peak	Average
0.16	54.88	37.65	N	65.46	55.46	10.58	17.81
0.18	53.08	36.61	N	64.49	54.49	11.41	17.88
0.56	28.57	24.51	N	56.00	46.00	27.43	21.49
2.97	27.15	22.93	N	56.00	46.00	28.85	23.07
6.16	26.61	23.98	N	60.00	50.00	33.39	26.02
11.85	32.69	28.03	N	60.00	50.00	27.31	21.97
0.18	51.65	34.90	H	64.49	54.49	12.84	19.59
0.20	49.89	31.77	H	63.61	53.61	13.72	21.84
0.56	24.05	18.65	H	56.00	46.00	31.95	27.35
2.96	25.50	21.85	H	56.00	46.00	30.50	24.15
6.02	31.02	28.78	H	60.00	50.00	28.98	21.22
11.91	24.22	19.79	H	60.00	50.00	35.78	30.21

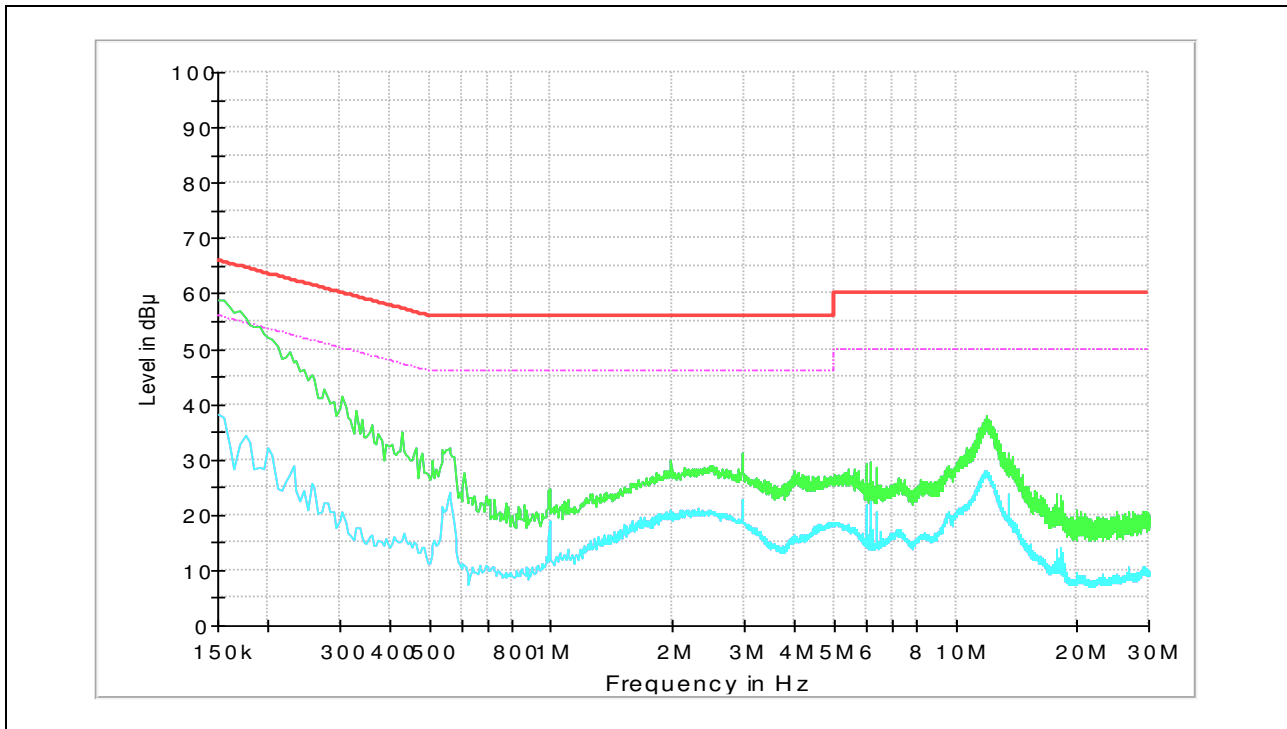
Remark;

- Line ( H ): Hot, Line ( N ): Neutral.
- All channel of operation were investigated and the worst-case emissions were reported using **BDR, DH5, High channel.**
- Traces shown in plot mad using a peak detector and average detector.
- The limit for Class B device(s) from 150 kHz to 30 MHz are specified in Section of the Title 47 CFR.
- Deviations to the Specifications: None.

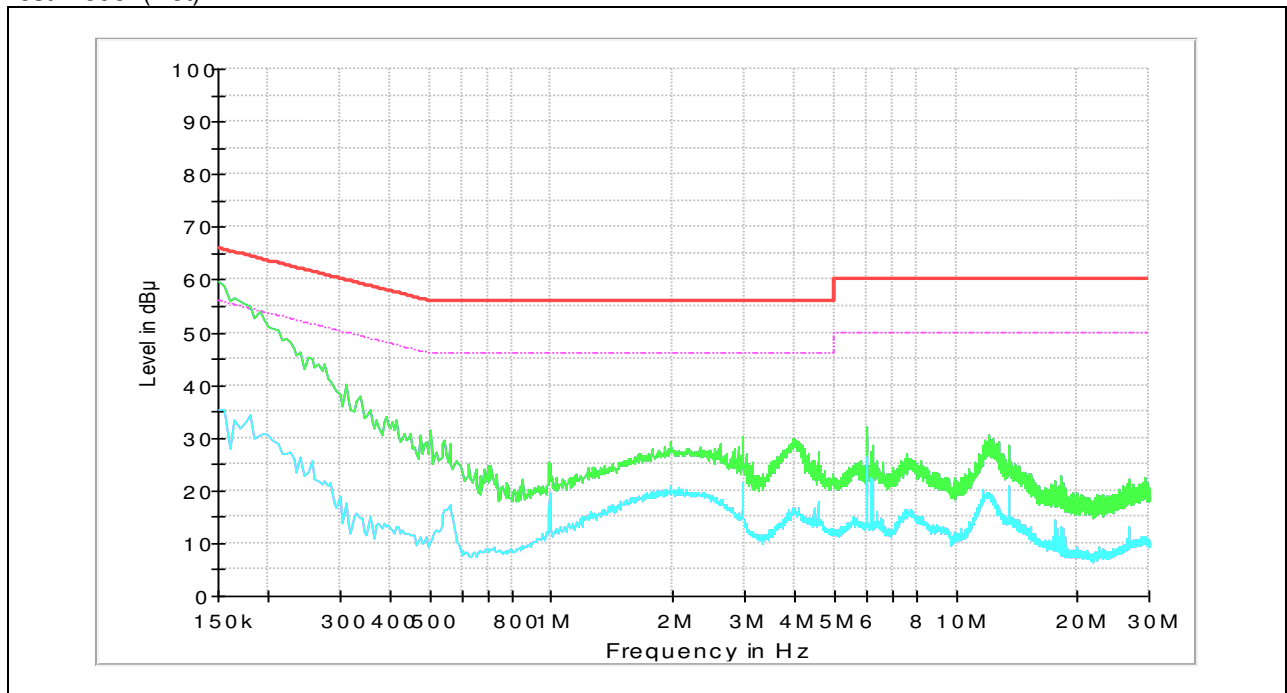
*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

## Plots of Conducted Power line

Test mode: (Neutral)



Test mode: (Hot)



The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.

---

## 9. Antenna Requirement

### 9.1. Standard Applicable

For intentional device, according to FCC 47 CFR Section §15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. And according to FCC 47 CFR Section §15.247 (b) if transmitting antennas of directional gain greater than 6 dB i are used, the power shall be reduced by the amount in dB that the gain of the antenna exceeds 6 dB i.

### 9.2. Antenna Connected Construction

Antenna used in this product is Planer inverted F Antenna with gain of 1.94 dB i.

**- End of the Test Report -**

---

*The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report cannot be reproduced, except in full, without prior written permission of the Company.*

**SGS Korea Co., Ltd. (Gunpo Laboratory)** 4, LS-ro 182beon-gil, Gunpo-si, Gyeonggi-do, Korea, 15807 <http://www.sgsgroup.kr>

RTT5041-20(2015.10.01)(3)

Tel. +82 31 428 5700 / Fax. +82 31 427 2370

A4(210 mm x 297 mm)